

# Nanomaterials for bottom-up manufacturing

*Jurriaan Huskens*

University of Twente, MESA+ Institute for Nanotechnology  
Molecular Nanofabrication group  
Enschede, The Netherlands

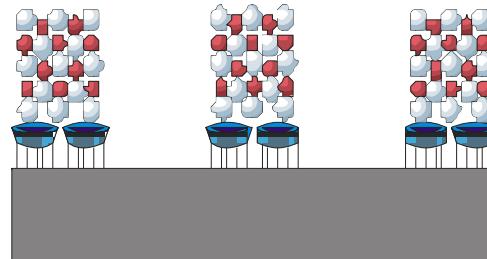


## General philosophy

Assembly: fundamental

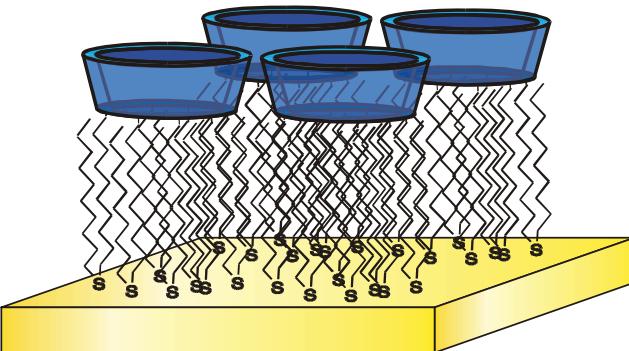
Patterning:

fundamental



3D nanostructures

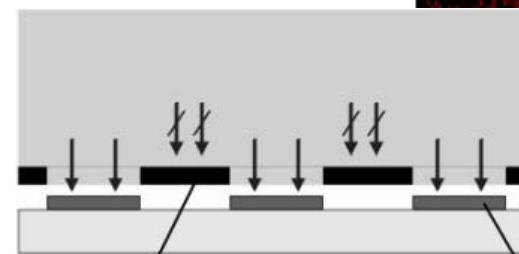
applied



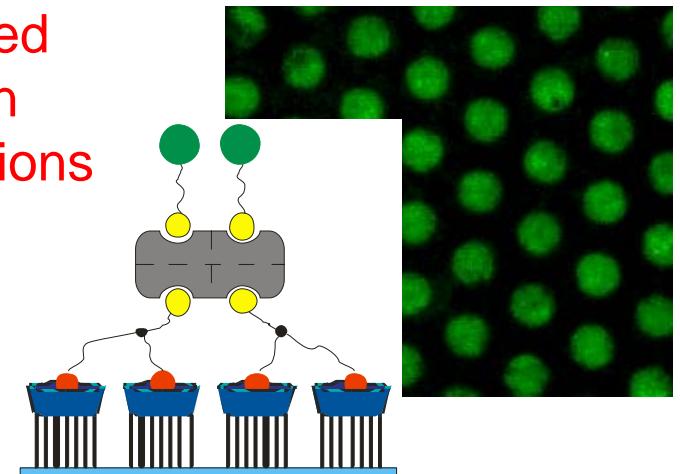
printboards, multivalency,  
supramolecular nanolithography

applied

flat stamps  
NIL patterning



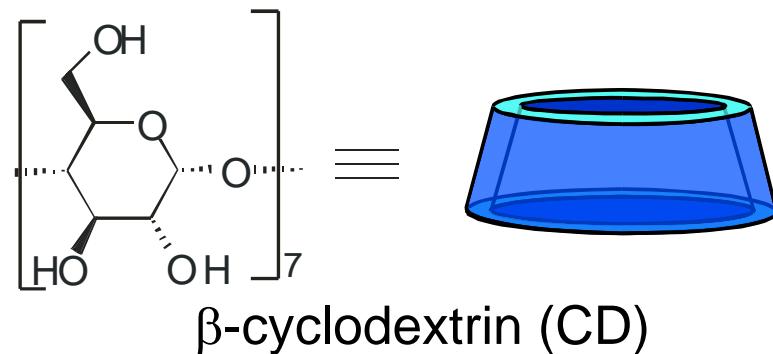
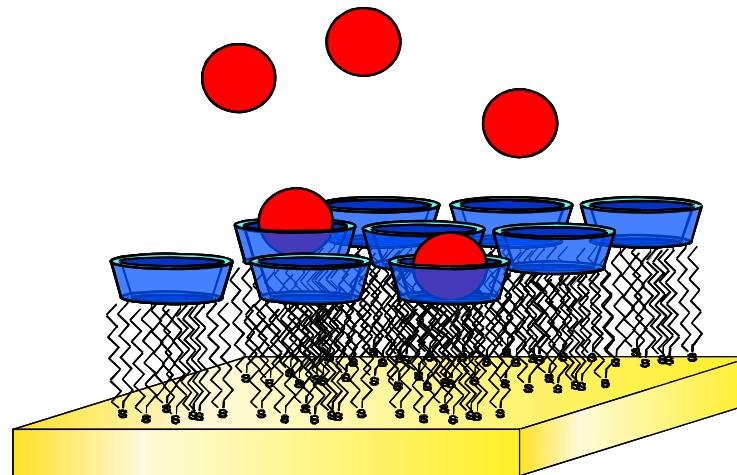
patterned  
protein  
constructions





# Molecular printboards

# CD monolayers on gold: infinite 2D receptor lattices



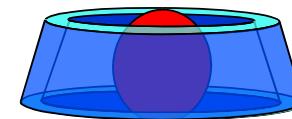
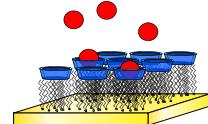
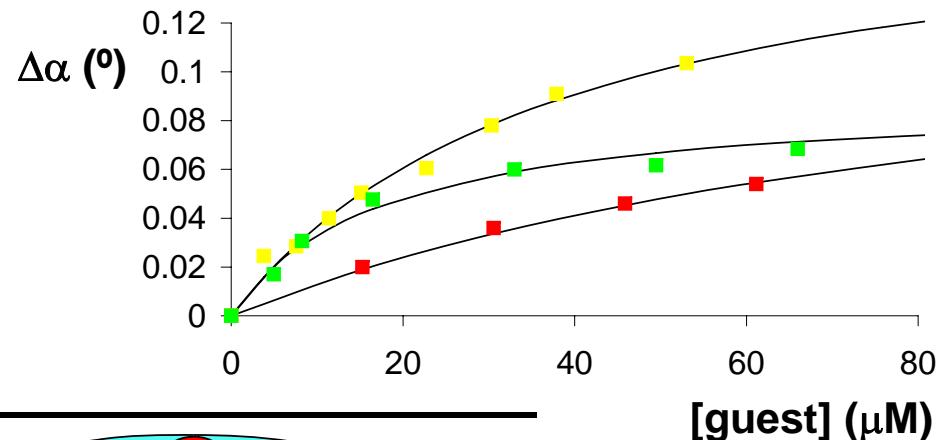
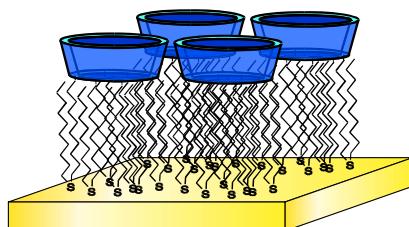
CA:	polarity:	$\theta_{adv} = 55^\circ$
EIS:	thickness:	2 - 3 nm
XPS:	bound sulfur:	65 %
SIMS:	molecular peaks:	(M+Au) <sup>+</sup>
AFM:	molecular order:	2.1 nm

M. W. J. Beulen, J. Bügler, M. R. de Jong, B. Lammerink, J. Huskens, H. Schönherr, G. J. Vancso, B. A. Boukamp, H. Wieder, A. Offenhäuser, W. Knoll, F. C. J. M. van Veggel, D. N. Reinhoudt, *Chem. Eur. J.* **2000**, 6, 1176



## Molecular printboards

Small guests at a CD monolayer:



	$K$ (M <sup>-1</sup> )	$\Delta\alpha_{sat}$ (°)	$K$ (M <sup>-1</sup> )	$\Delta H$ (kcal mol <sup>-1</sup> )	$T\Delta S$ (kcal mol <sup>-1</sup> )
	$9.9 \cdot 10^3$	0.145	$1.0 \cdot 10^4$	-6.1	-0.7
	$2.6 \cdot 10^4$	0.179	$3.0 \cdot 10^4$	-5.2	0.9
	$5.7 \cdot 10^4$	0.090	$6.8 \cdot 10^4$	-5.9	0.7

M. R. de Jong,  
J. Huskens,  
D. N. Reinhoudt,  
*Chem. Eur. J.*  
**2001**, 7, 4164

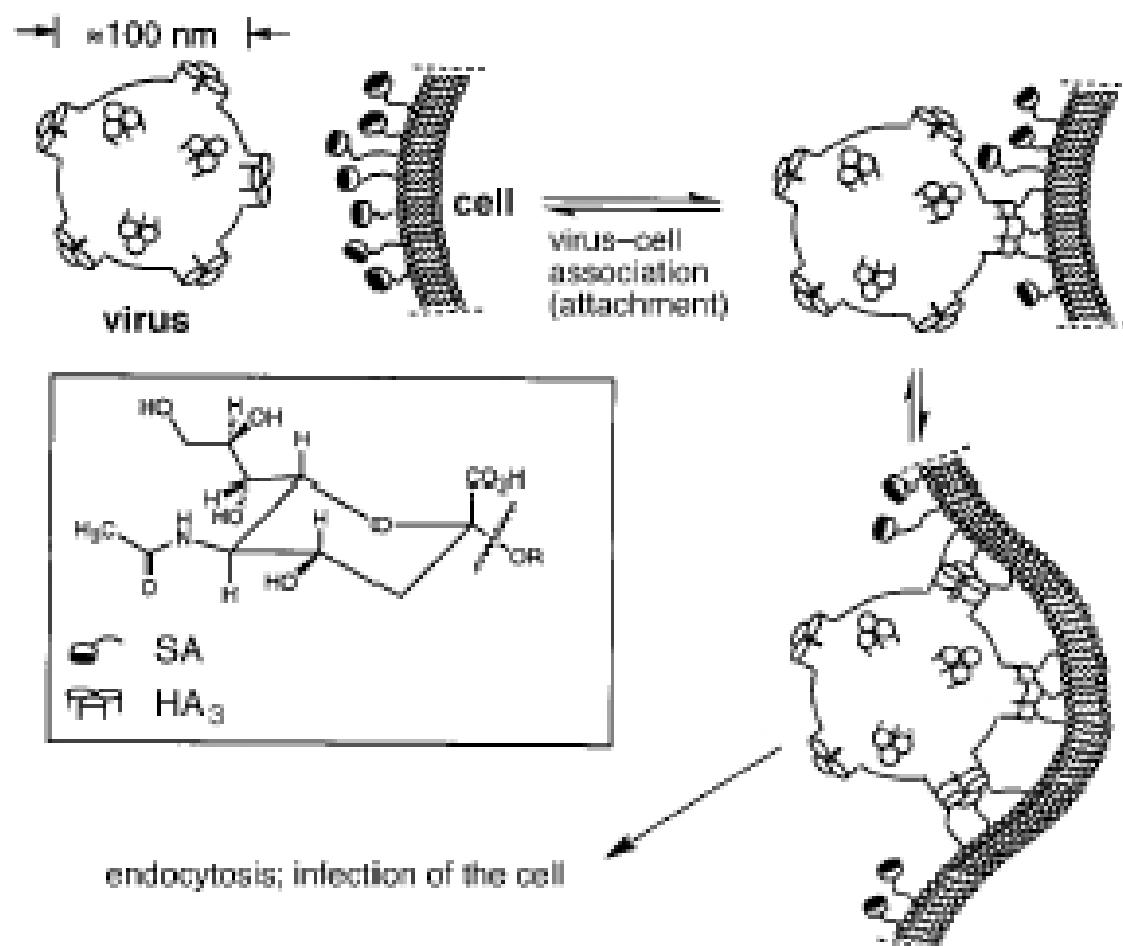


## General introduction to multivalency

Multivalency **at interfaces**:

Examples in Nature:

cell membrane interactions  
with bacteria and viruses:

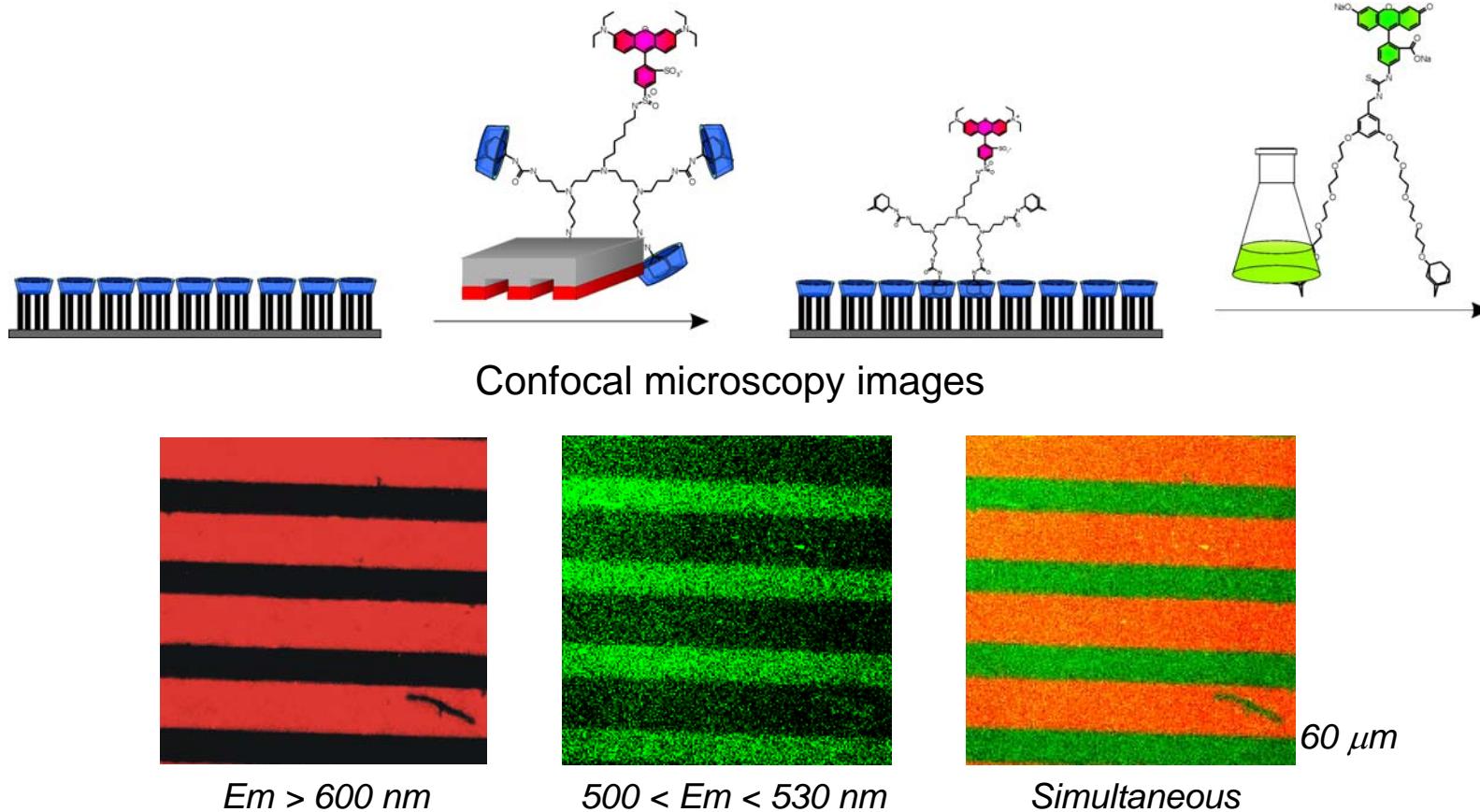


M. Mammen, S.-K. Choi, G. M.  
Whitesides, *Angew. Chem. Int.*  
*Ed.* **1998**, *37*, 2754



## $\mu$ CP on SAMs

Patterning with multiple multivalent molecules:

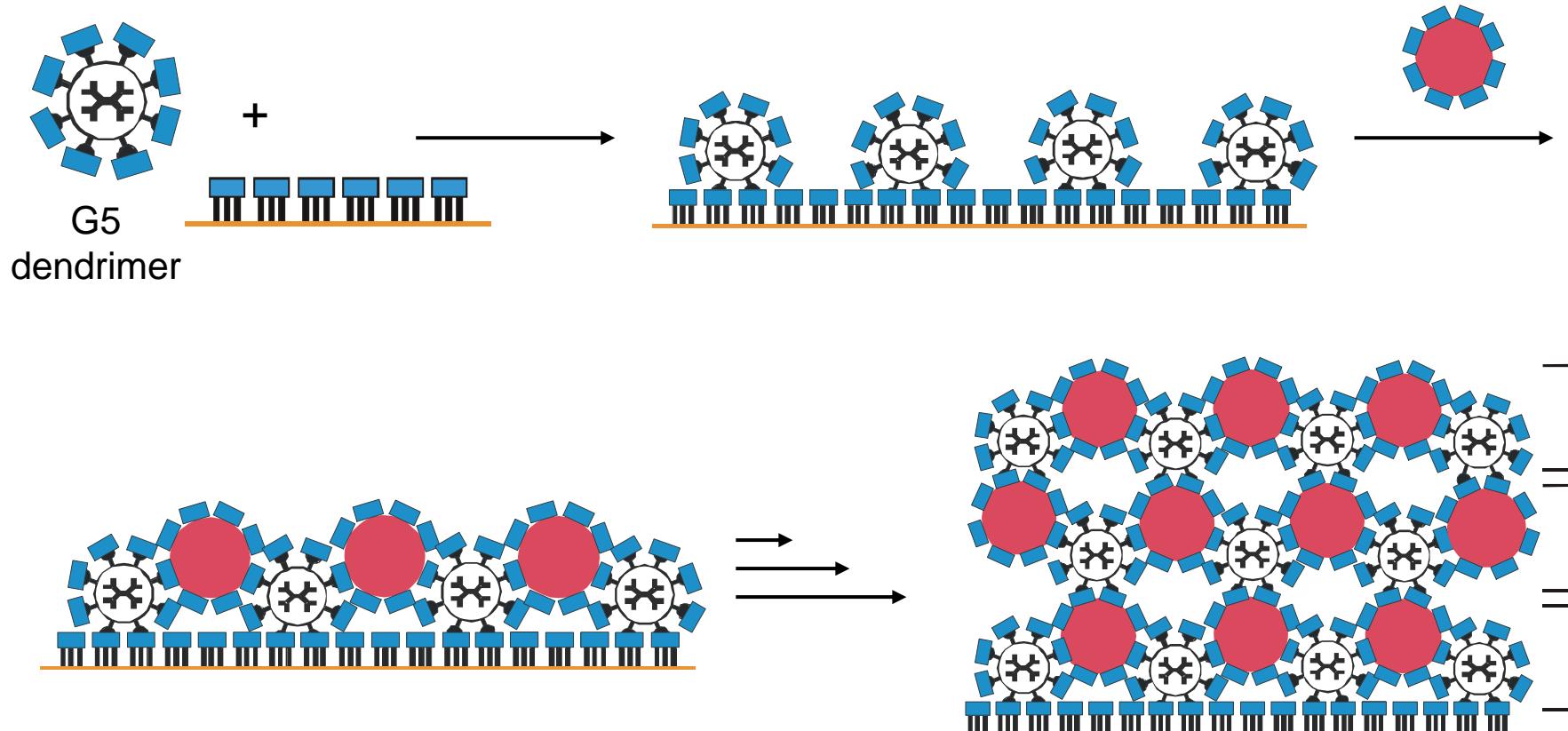


S. Onclin, A. Mulder, J. Huskens, B. J. Ravoo, D. N. Reinhoudt, *Langmuir* **2004**, *20*, 5460  
A. Mulder, S. Onclin, M. Péter, J. P. Hoogenboom, H. Beijleveld, J. ter Maat, M. F. García-Parajó, B. J. Ravoo, J. Huskens, N. F. van Hulst, D. N. Reinhoudt, *Small* **2005**, *1*, 242



## Supramolecular materials

Supramolecular layer-by-layer assembly scheme using CD-Au colloids and adamantyl-functionalized dendrimers:



O. Crespo-Biel, B. Dordi, D. N. Reinhoudt, J. Huskens, *J. Am. Chem. Soc.* **2005**, 127, 7594

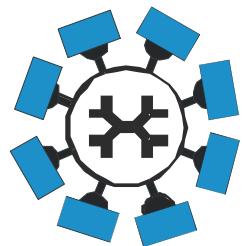
Layer-by-layer assembly: G. Decher, *Science* **1997**, 277, 1232



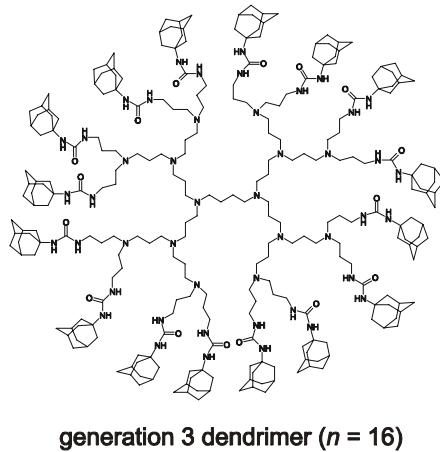
## Supramolecular materials

Supramolecular building blocks for LBL assembly:

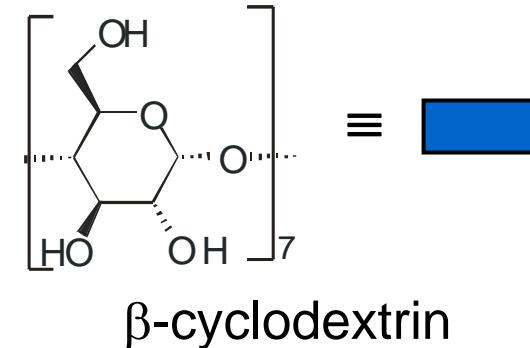
Adamantyl dendrimers:



≡



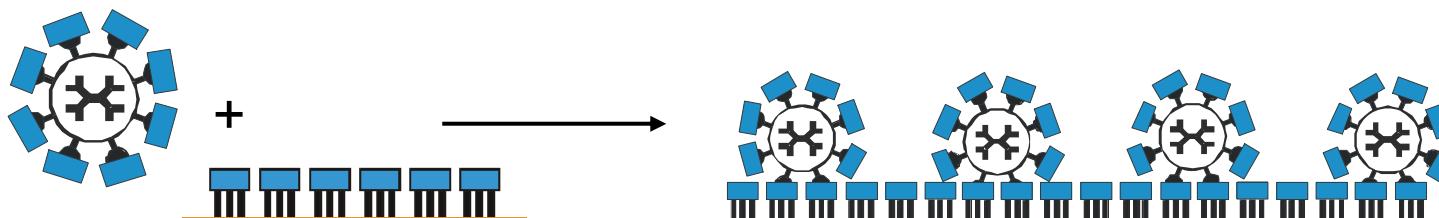
generation 3 dendrimer ( $n = 16$ )



$\beta$ -cyclodextrin

J. J. Michels, M. W. P. L. Baars, E. W. Meijer, J. Huskens, D. N. Reinhoudt, *J. Chem. Soc., Perkin Trans. 2*, **2000**, 1914

Molecular printboards:



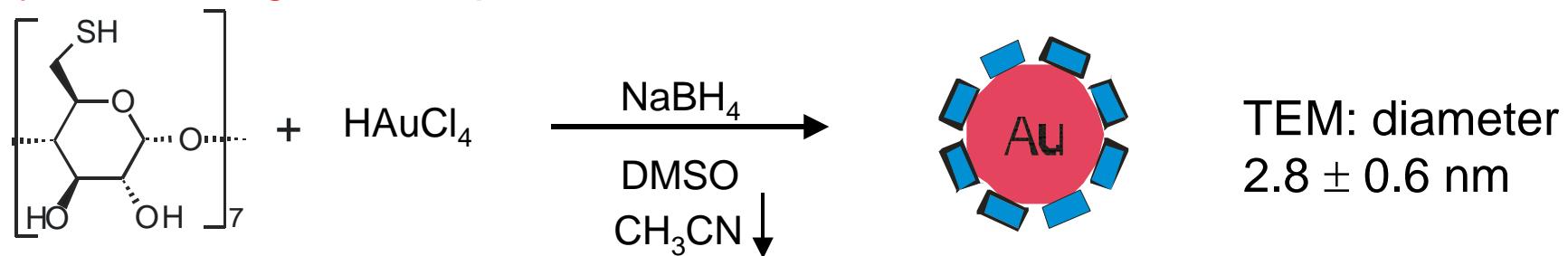
J. Huskens, M. A. Deij, D. N. Reinhoudt, *Angew. Chem. Int. Ed.* **2002**, *41*, 4467;  
T. Auletta, B. Dordi, A. Mulder, A. Sartori, S. Onclin, C. M. Bruinink, C. A. Nijhuis,  
H. Beijleveld, M. Péter, H. Schönherr, G. J. Vancso, A. Casnati, R. Ungaro, B. J.  
Ravoo, J. Huskens, D. N. Reinhoudt, *Angew. Chem. Int. Ed.* **2004**, *43*, 369



## Supramolecular materials

Supramolecular building blocks for LBL assembly:

Cyclodextrin gold nanoparticles:



J. Liu, W. Ong, E. Román, M. J. Lynn, A. E. Kaifer, *Langmuir* **2000**, *16*, 3000

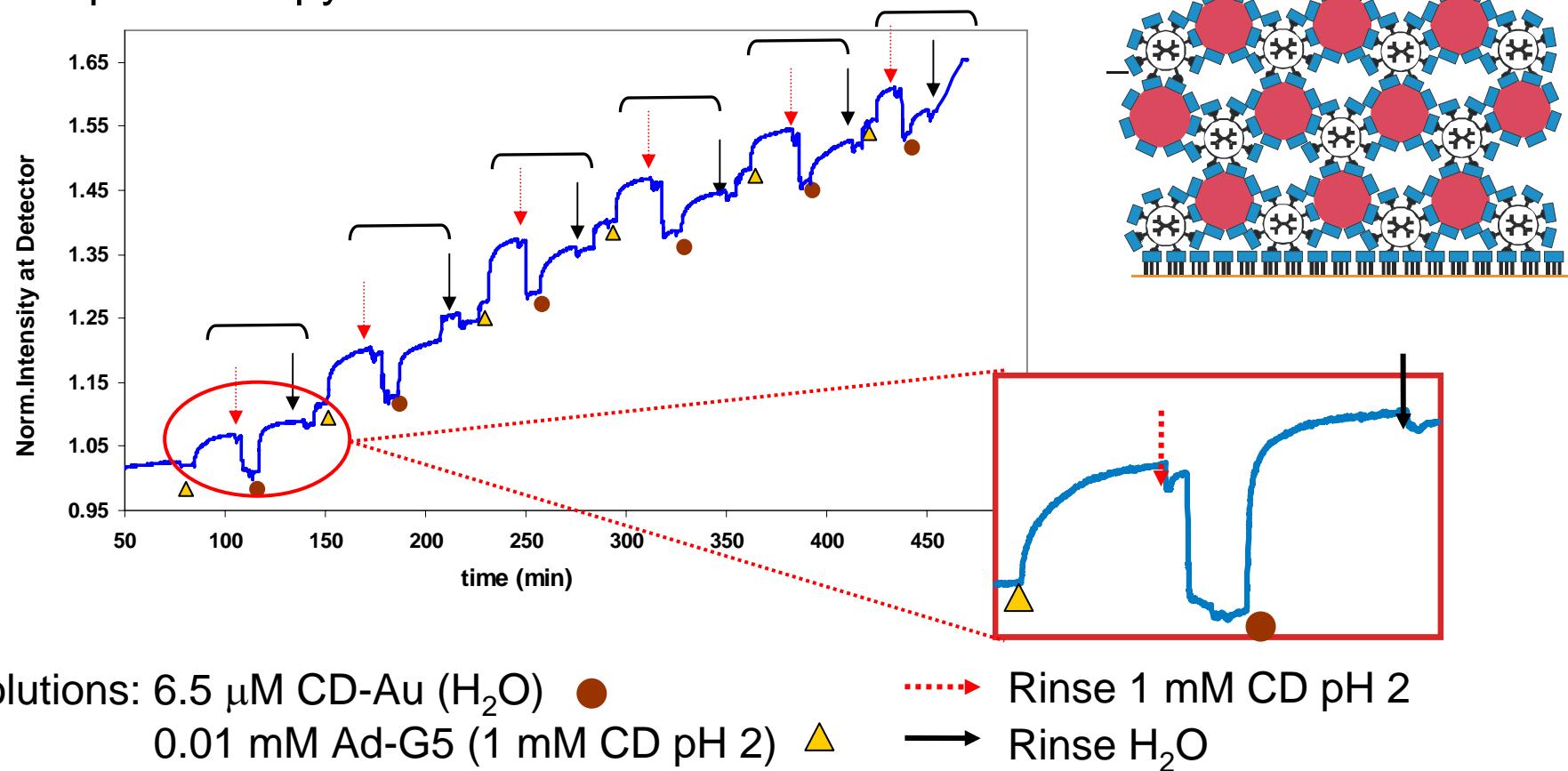
Supramolecular multivalent aggregation:





## Supramolecular materials

Layer-by-layer assembly using CD-Au colloids and Ad dendrimers:  
SPR spectroscopy:



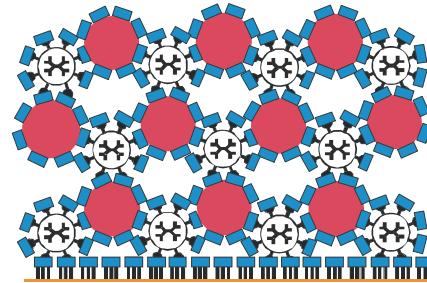
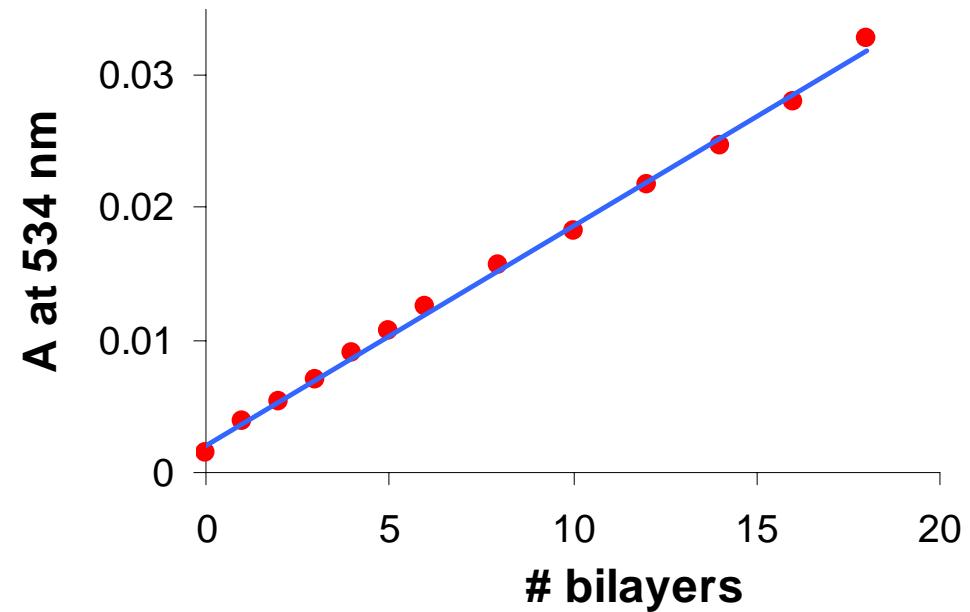
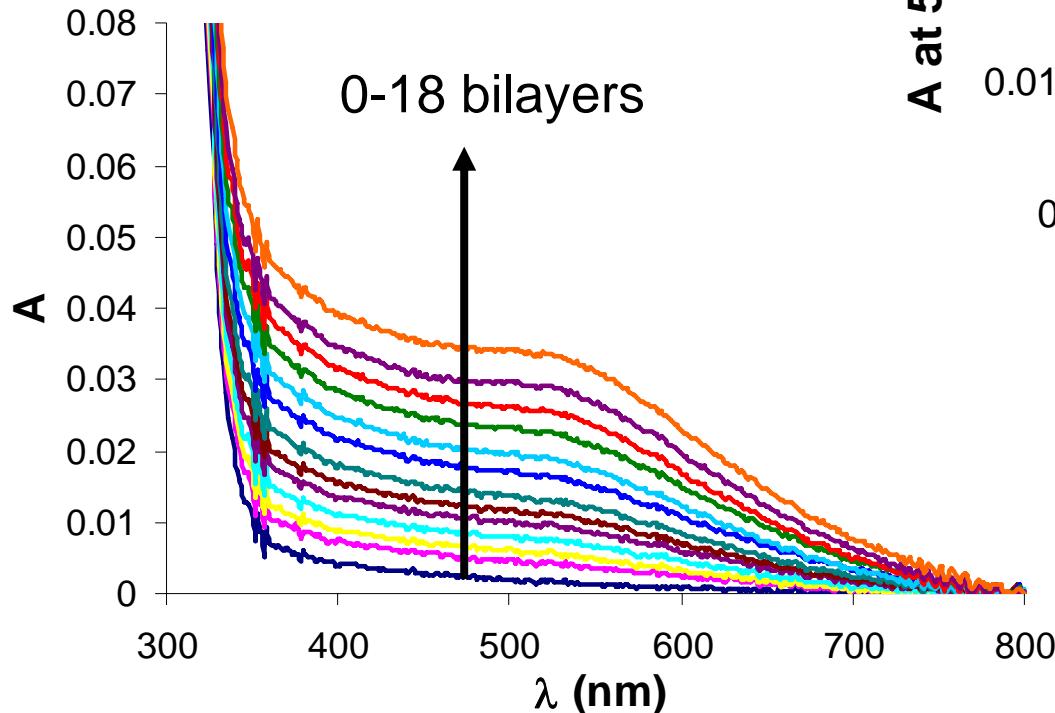
O. Crespo-Biel, B. Dordi, D. N. Reinhoudt, J. Huskens, *J. Am. Chem. Soc.* **2005**, 127, 7594



## Supramolecular materials

Layer-by-layer assembly using CD-Au colloids and Ad dendrimers:  
UV/Vis at glass substrates:

Quantitative interpretation possible:  
1 monolayer of particles per bilayer





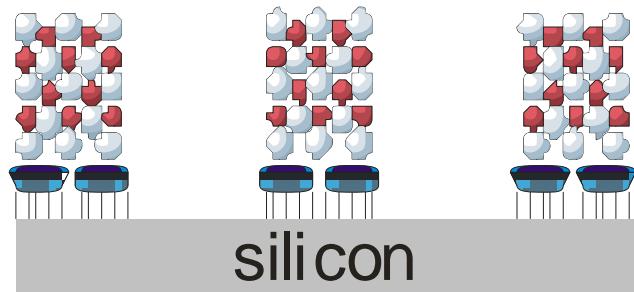
## 3D Supramolecular materials

Towards patterned LBL assemblies:

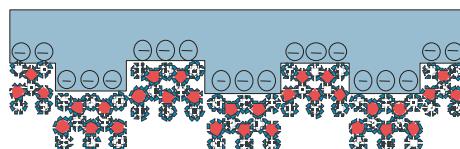
3D Nanofabrication:

x,y: top-down patterning

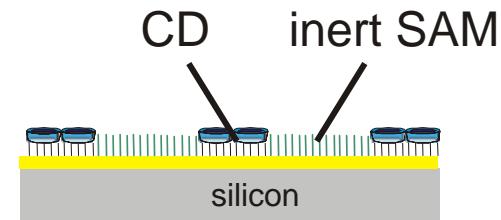
z: LBL assembly



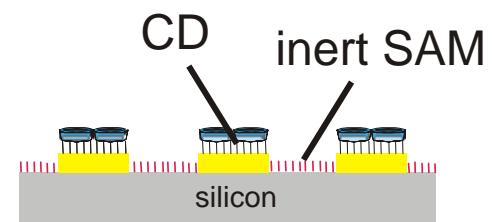
Structures on  
patterned  
stamp:  
( $\mu$ CP)



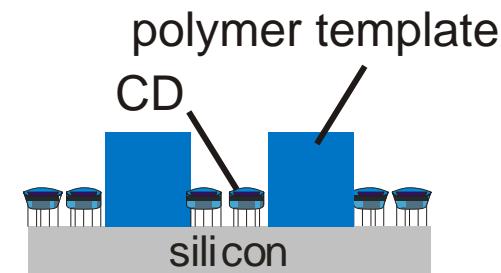
Patterned SAMs:  
( $\mu$ CP, NIL)



Patterned gold:  
( $\mu$ CP+etching,  
NIL+metal lift-off,  
sieve evaporation)



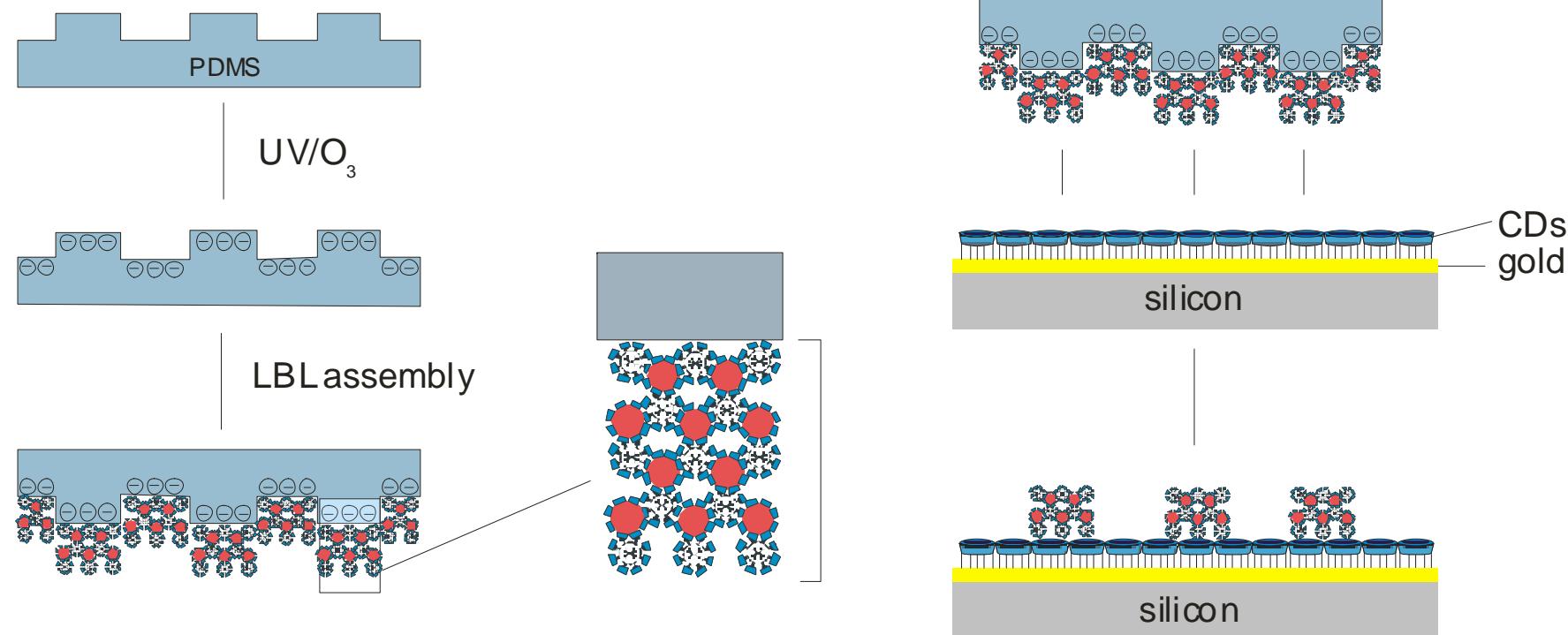
Patterned mask:  
(NIL)





## 3D Supramolecular materials

Alternative: LBL on PDMS stamp followed by assembly transfer by  $\mu$ CP:

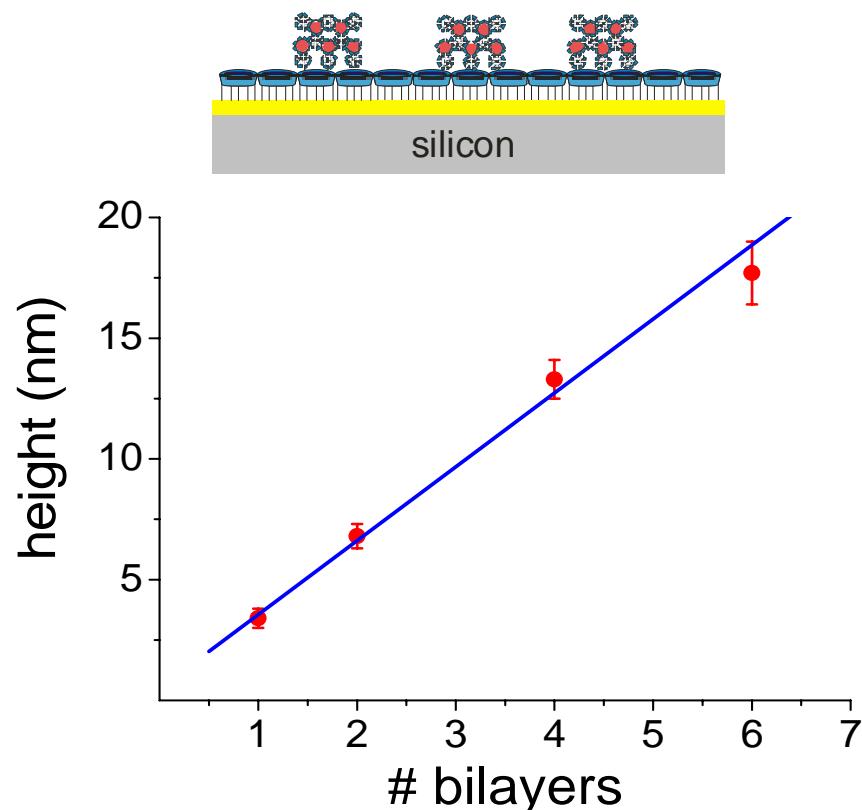


O. Crespo-Biel, B. Dordi, P. Maury, M. Péter, D. N. Reinhoudt, J. Huskens, *Chem. Mater.* **2006**, 18, 2545  
LBL in combination with  $\mu$ CP: J. Park, P. T. Hammond, *Adv. Mater.* **2004**, 16, 520

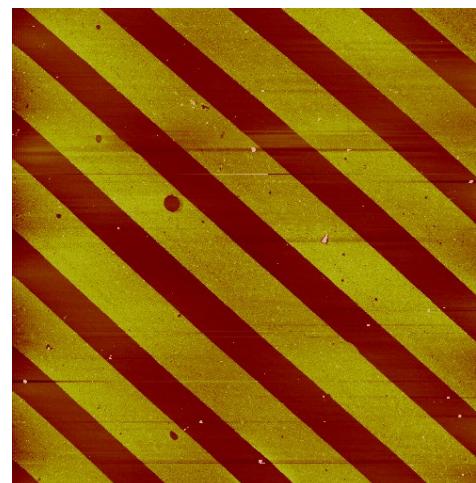


## 3D Supramolecular materials

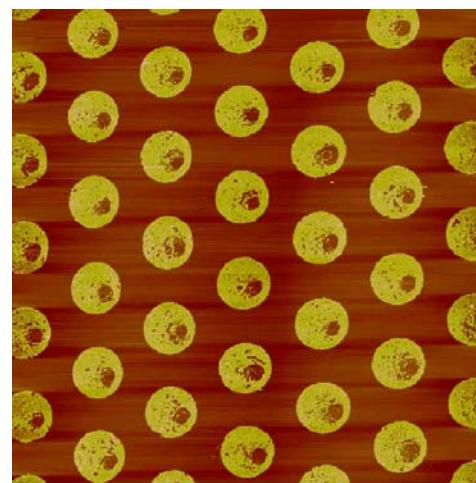
Patterned LBL assemblies by  $\mu$ CP:



Assemblies are stable against  
rinsing with competitive CD solutions



AFM height image  
( $80 \times 80 \mu\text{m}^2$ )  
2 bilayers: 7 nm



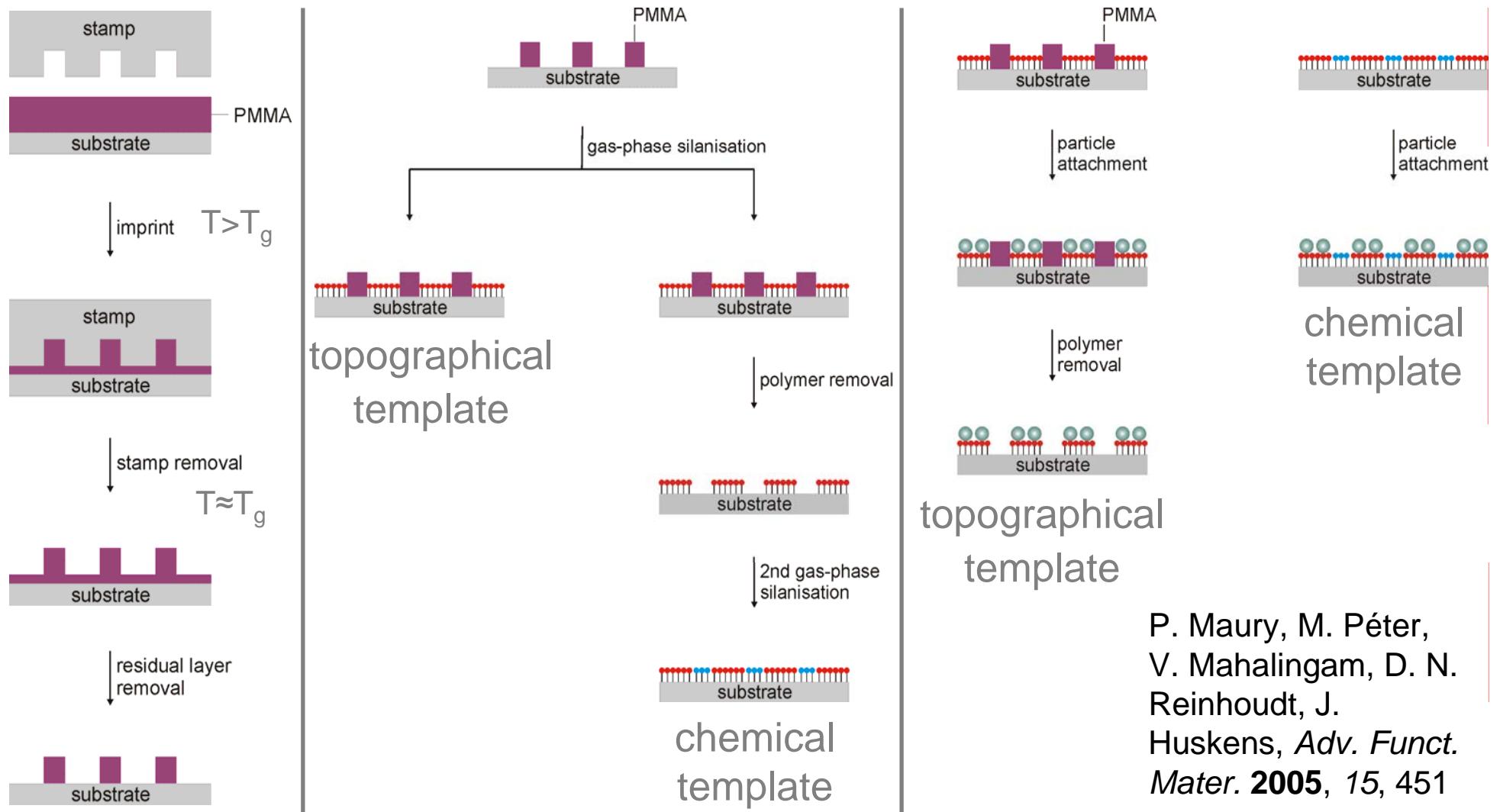
AFM height image  
( $60 \times 60 \mu\text{m}^2$ )  
4 bilayers: 14 nm

O. Crespo-Biel, P.  
Maury, M. Péter, B.  
Dordi, D. N. Reinhoudt,  
J. Huskens, *Chem.  
Mater.* **2006**, 18, 2545



# Directed nanoparticle assembly on NIL templates

Nanofabrication scheme **including NIL and directed nanoparticle deposition**:

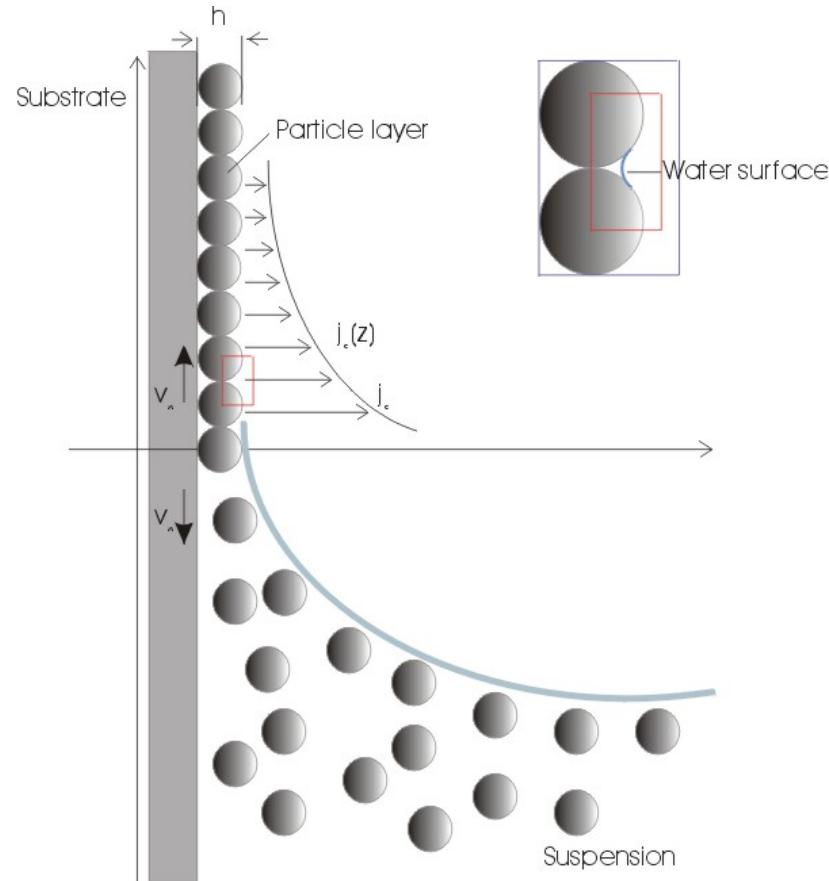


P. Maury, M. Péter,  
V. Mahalingam, D. N.  
Reinhoudt, J.  
Huskens, *Adv. Funct.  
Mater.* **2005**, 15, 451

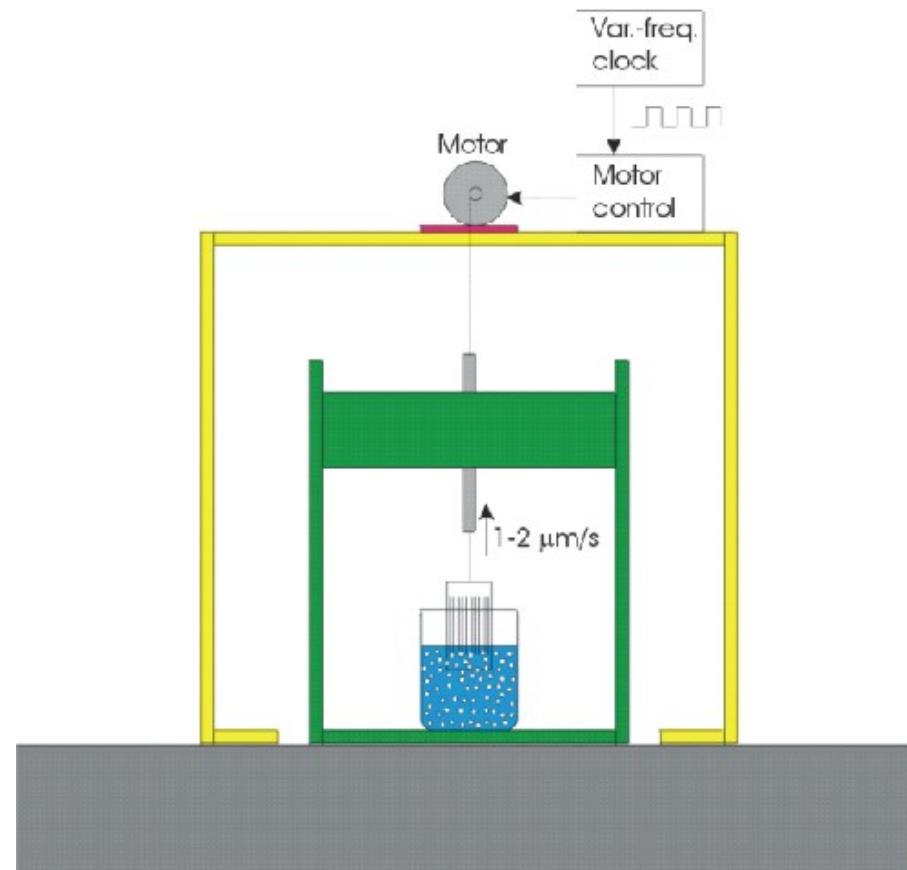


## Directed nanoparticle assembly on NIL templates

Improved particle deposition process: **controlled wetting and capillary forces**:



physical principle

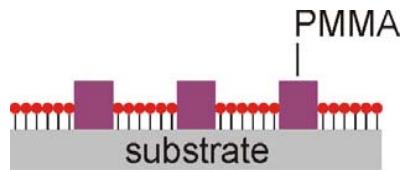


vertical NP deposition tool

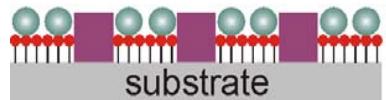


## Directed nanoparticle assembly on NIL templates

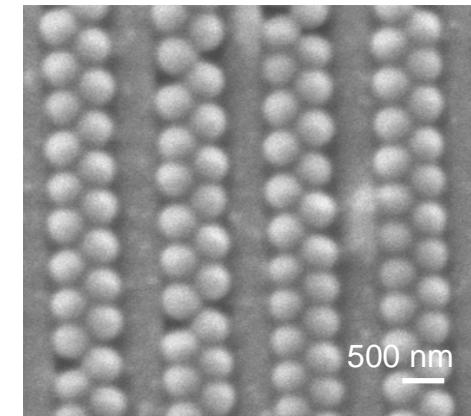
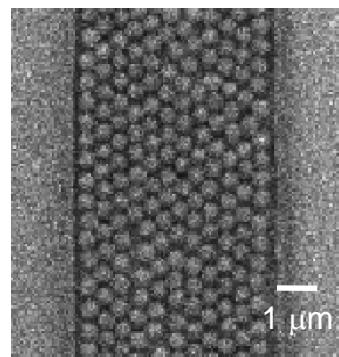
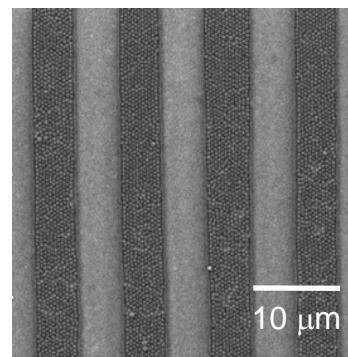
Particle adsorption **in PMMA templates** using **vertical colloidal deposition**:



↓  
particle  
attachment

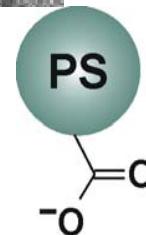


P. Maury, M.  
Escalante, M. Péter, D.  
N. Reinhoudt, J.  
Huskens, *Adv. Mater.*  
**2005**, 17, 2718

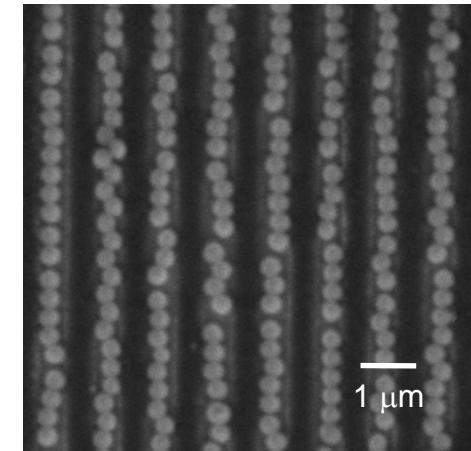
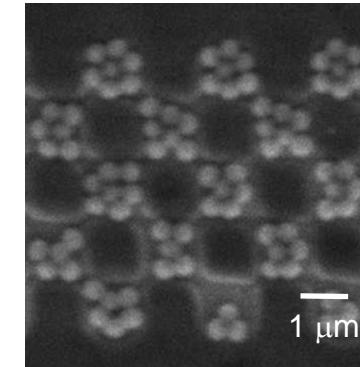
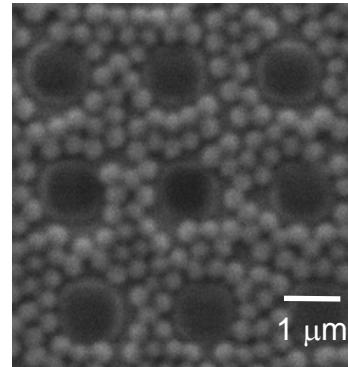


5  $\mu\text{m}$  lines

1  $\mu\text{m}$  holes



600 nm lines

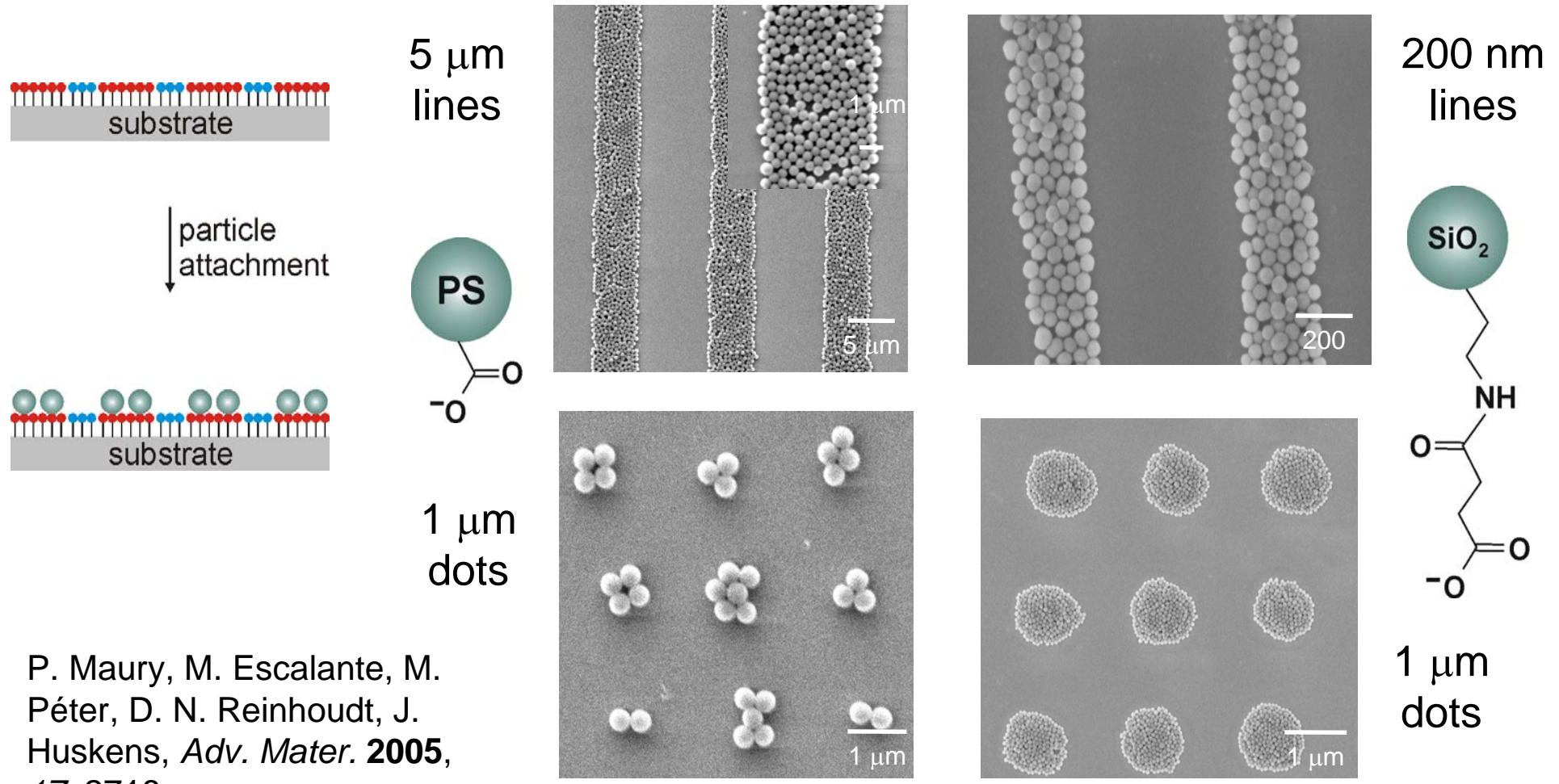


500 nm lines



## Directed nanoparticle assembly on NIL templates

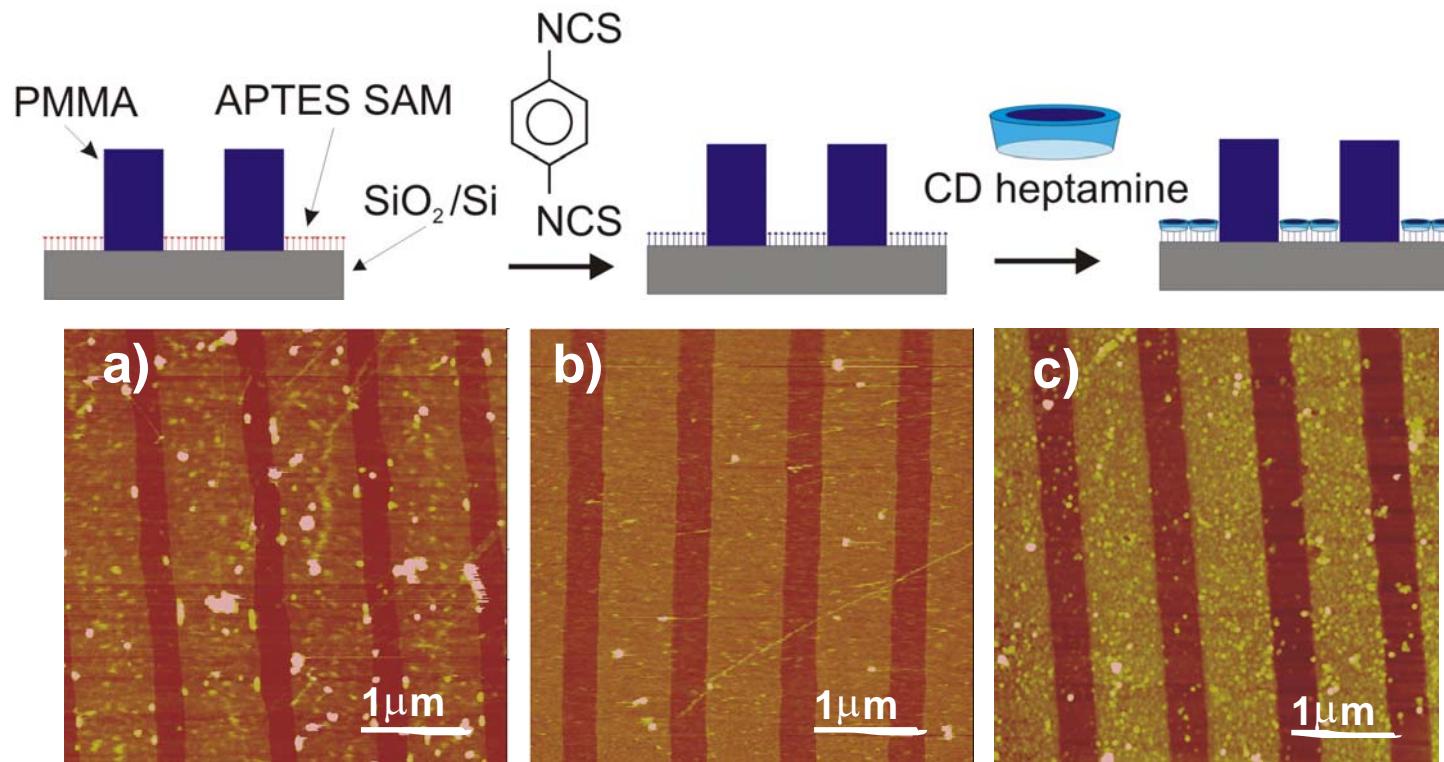
Particle adsorption on NIL-patterned SAMs using vertical colloidal deposition:





## NIL-patterned molecular printboards

NIL-patterned CD monolayers on  $\text{SiO}_2$ :  
templates for **multivalent supramolecular adsorption**:



AFM height: 0.9 nm  
(after polymer removal)

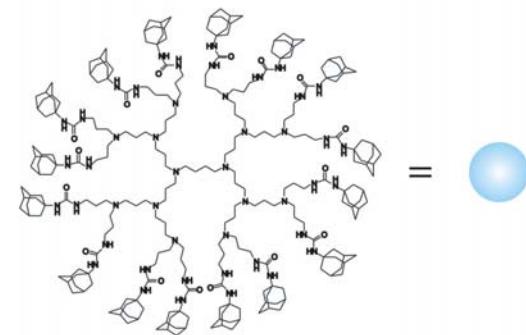
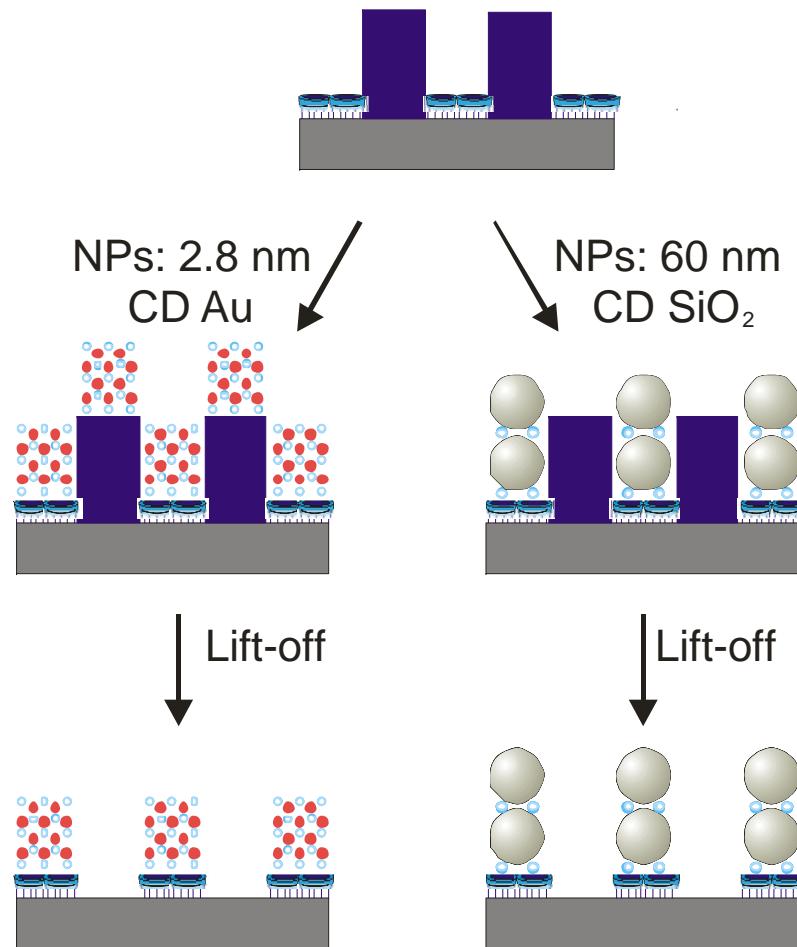
0.9 nm

P. Maury, M. Péter, O. Crespo-Biel, X. Y. Ling, D. N.  
Reinhoudt, J. Huskens, *Nanotechnology* **2007**, 18, 044007



## 3D Supramolecular materials

Integration with layer-by-layer (LBL) assembly:



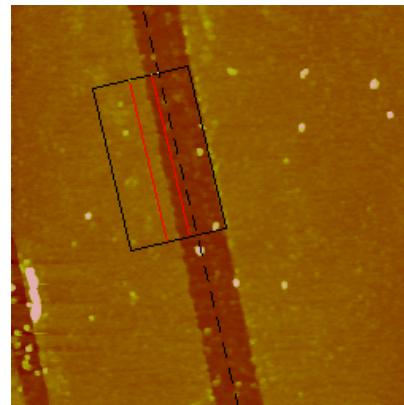
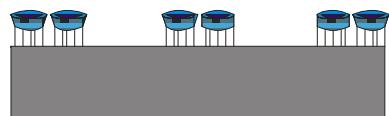
P. Maury, M. Péter, O. Crespo-Biel, X. Y. Ling, D. N. Reinhoudt, J. Huskens,  
*Nanotechnology* **2007**, 18, 044007



## 3D Supramolecular materials

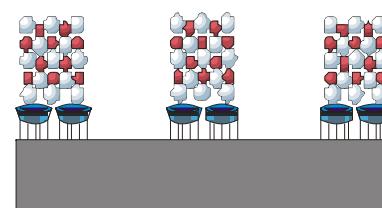
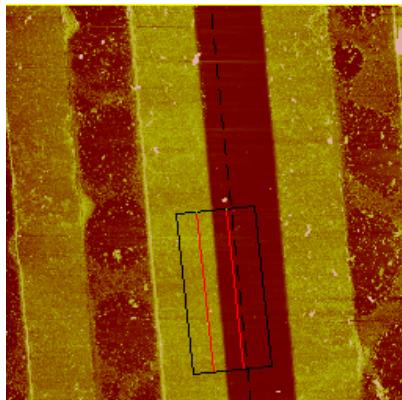
NIL-patterned polymer masks for directed LBL: results:

NIL-patterned CD SAMs:



AFM height image  
( $8 \times 8 \mu\text{m}^2$ )  
no bilayers: 2 nm  
**(7 process steps)**

NIL-patterned CD SAMs followed by LBL, then polymer removal:



AFM height image  
( $30 \times 30 \mu\text{m}^2$ )  
2 bilayers: 6 nm



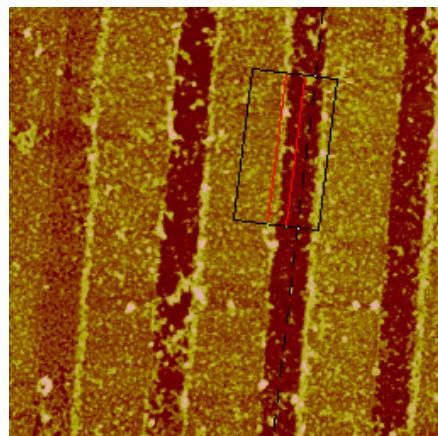
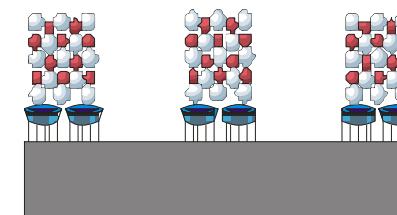
AFM height image  
( $30 \times 30 \mu\text{m}^2$ )  
4 bilayers: 10 nm  
**(15 process steps!)**



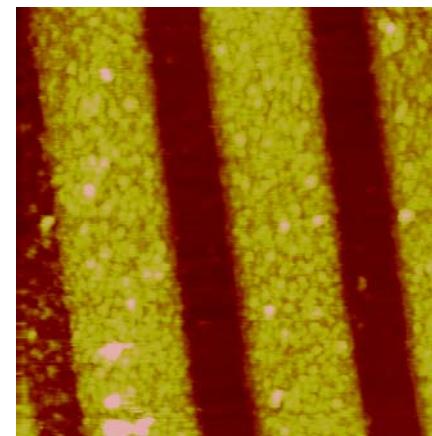
## 3D Supramolecular materials

NIL-patterned polymer masks for directed LBL: results:

NIL-patterned CD SAMs followed by LBL:  
submicron patterns:



AFM height image  
( $4 \times 4 \mu\text{m}^2$ )  
2 bilayers: 5 nm  
line width: 700 nm



AFM height image  
( $2.8 \times 2.8 \mu\text{m}^2$ )  
4 bilayers: 10 nm  
line width: 700 nm

15 process steps !

J. Huskens, P. Maury, O. Crespo-Biel, M. Péter, D. N. Reinhoudt, *Proceed. Instit. Mech. Engin. N: J. Nanoengin. Nanosys.* **2006**, 220, 157

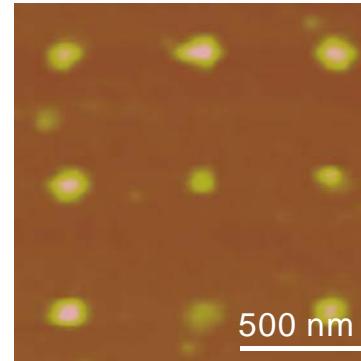
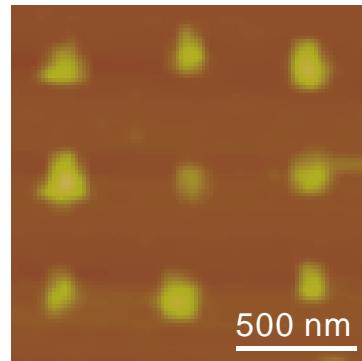
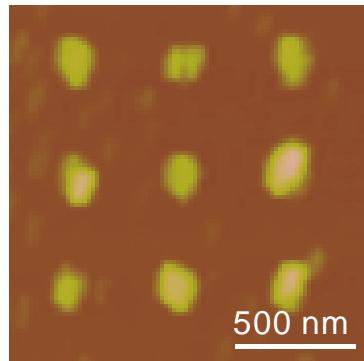
P. Maury, M. Péter, O. Crespo-Biel, X. Y. Ling, D. N. Reinhoudt, J. Huskens, *Nanotechnology* **2007**, 18, 044007



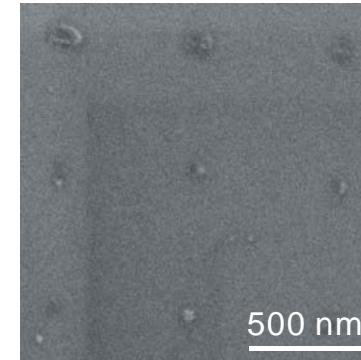
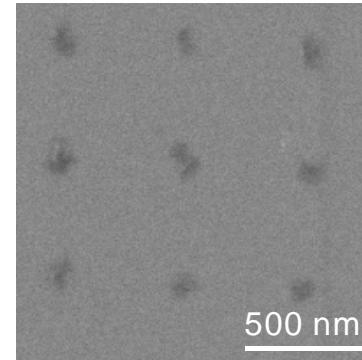
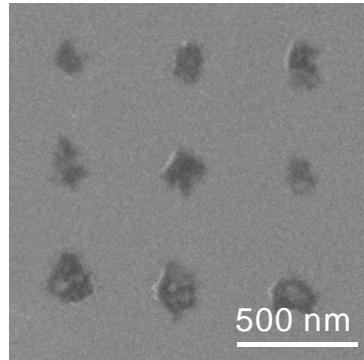
## 3D Supramolecular materials

NIL-patterned polymer masks for directed LBL:  
results using an e-beam made master:

AFM



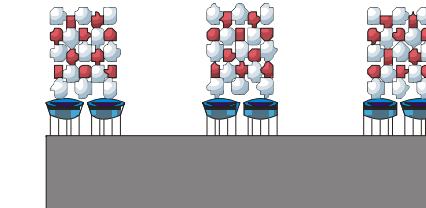
SEM



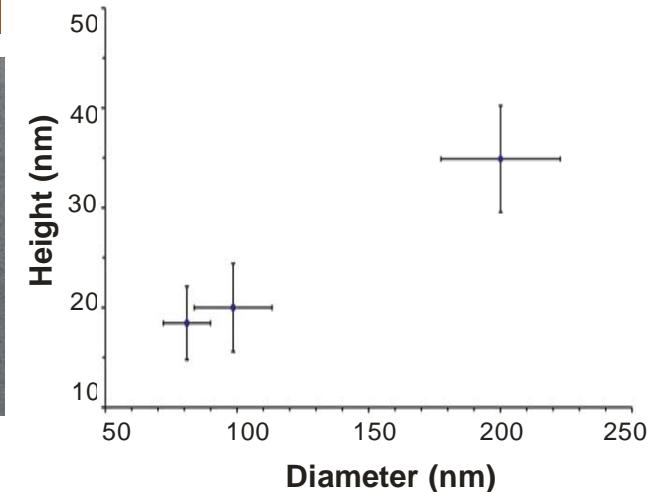
dot width: 200 nm

100 nm

50 nm



15 bilayers:  
37 process steps !!



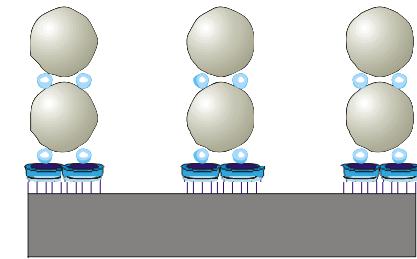
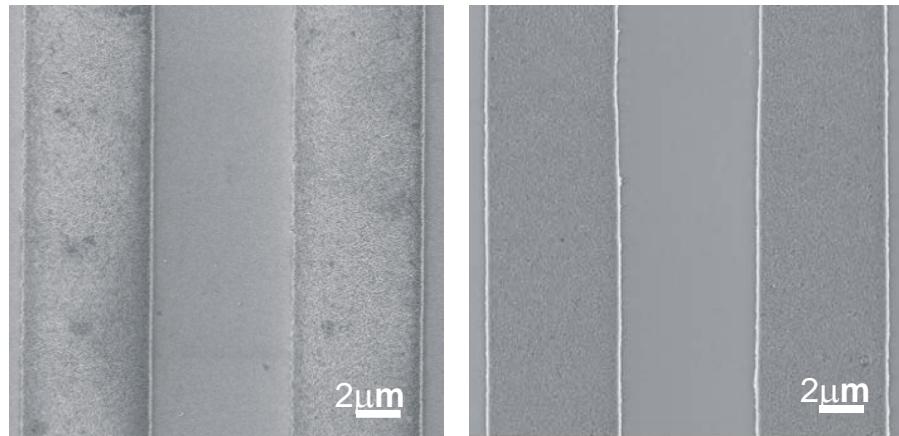
P. Maury, M. Péter, O. Crespo-Biel, X. Y. Ling, D. N. Reinhoudt,  
J. Huskens, *Nanotechnology* **2007**, *18*, 044007



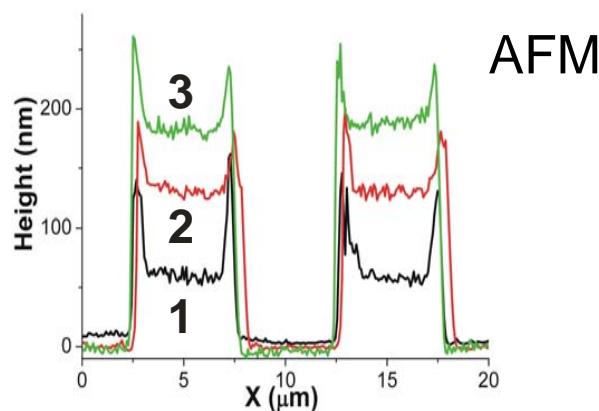
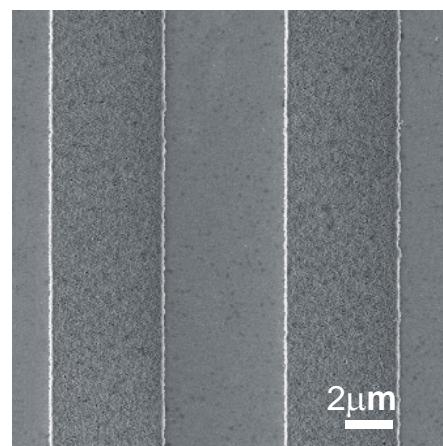
## 3D Supramolecular materials

NIL-patterned polymer masks for directed LBL:  
LBL with 60 nm CD SiO<sub>2</sub> NPs:

SEM



1-3 bilayers:  
height = n x 60 nm



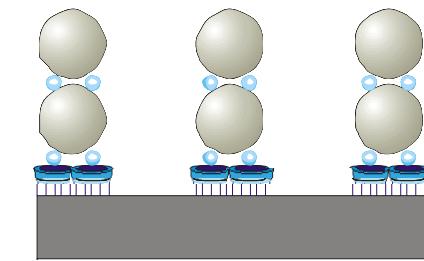
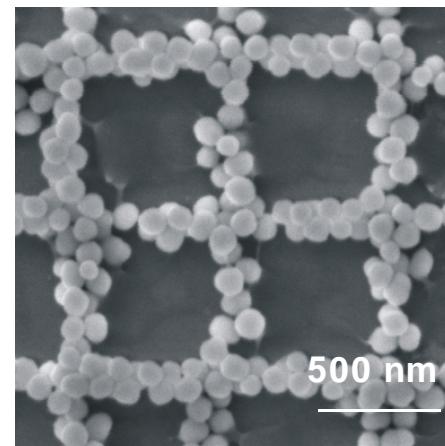
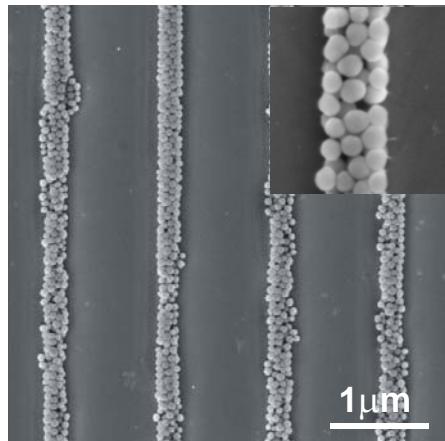
P. Maury, M. Péter, O.  
Crespo-Biel, X. Y. Ling, D.  
N. Reinhoudt, J. Huskens,  
*Nanotechnology* **2007**, *18*,  
044007



## 3D Supramolecular materials

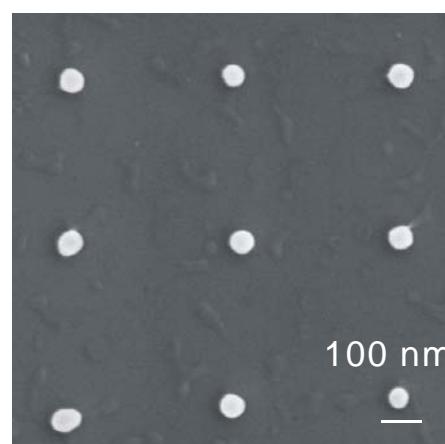
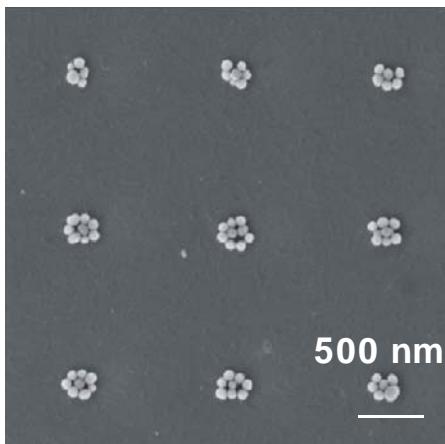
NIL-patterned polymer masks for directed LBL:  
LBL with 60 nm CD SiO<sub>2</sub> NPs:

2 bilayers on  
line and grid  
patterns



SEM

1 bilayer on  
dot patterns

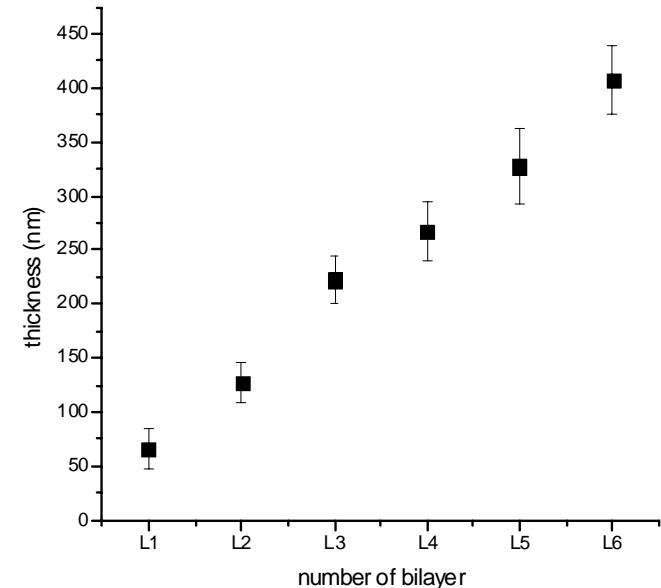
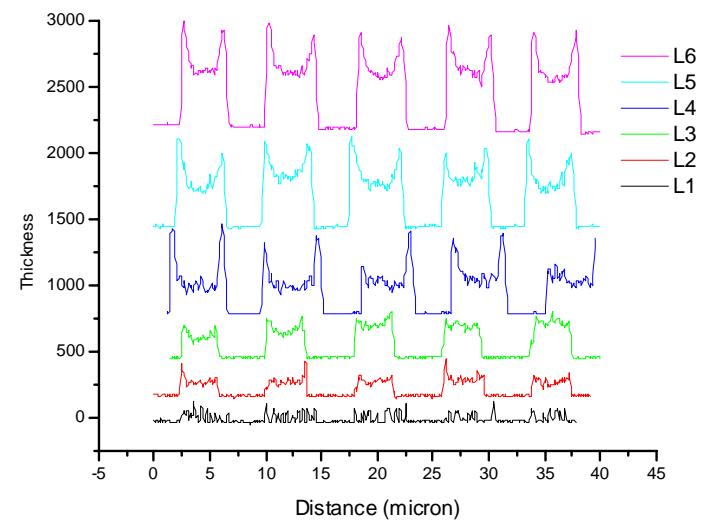
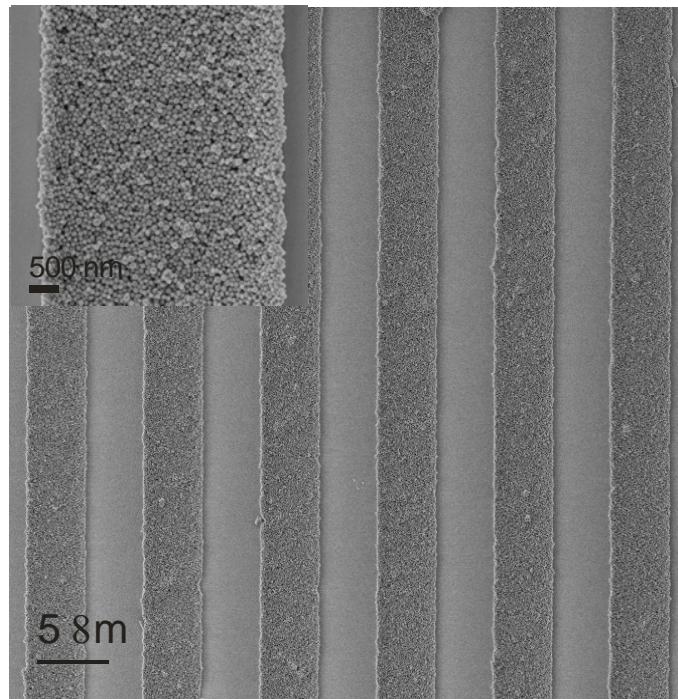
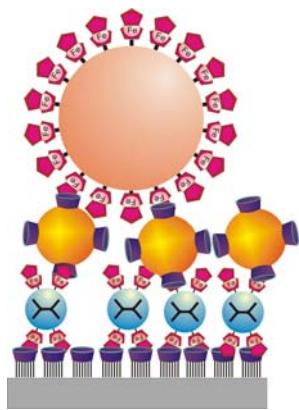


P. Maury, M. Péter, O.  
Crespo-Biel, X. Y. Ling, D.  
N. Reinhoudt, J. Huskens,  
*Nanotechnology* **2007**, *18*,  
044007



## 3D Supramolecular materials

NIL-patterned polymer masks for directed LBL:  
LBL with 3 nm CD Au and 60 nm Fc SiO<sub>2</sub> NPs:



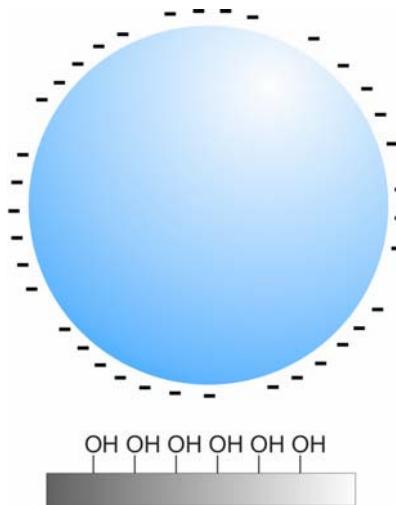
X. Y. Ling, I. Y. Phang, G. J. Vancso, D. N. Reinhoudt,  
J. Huskens, *Int. J. Mol. Sci.* **2008**, 9, 486



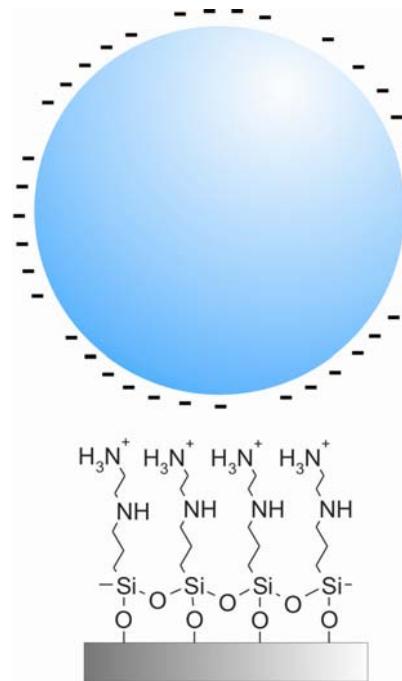
## Nanoparticle-substrate interface chemistry

Key question: **What is the role of the interface chemistry on the assembly (order, reversibility) of large nanoparticles?**

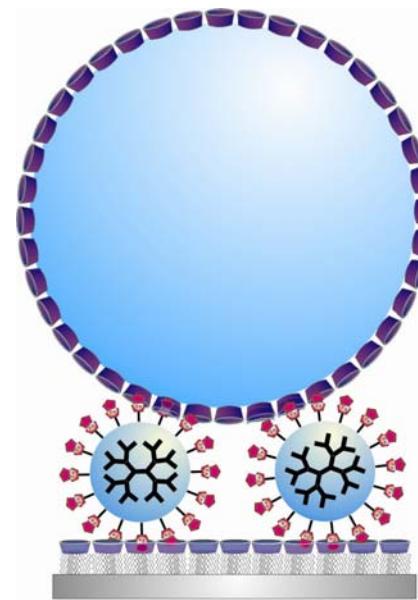
Case study: 500 nm polystyrene NPs:



physisorption



electrostatic



host-guest

X. Y. Ling, L. Malaquin, D. N. Reinhoudt, H. Wolf, J. Huskens, *Langmuir* **2007**, 23, 9990

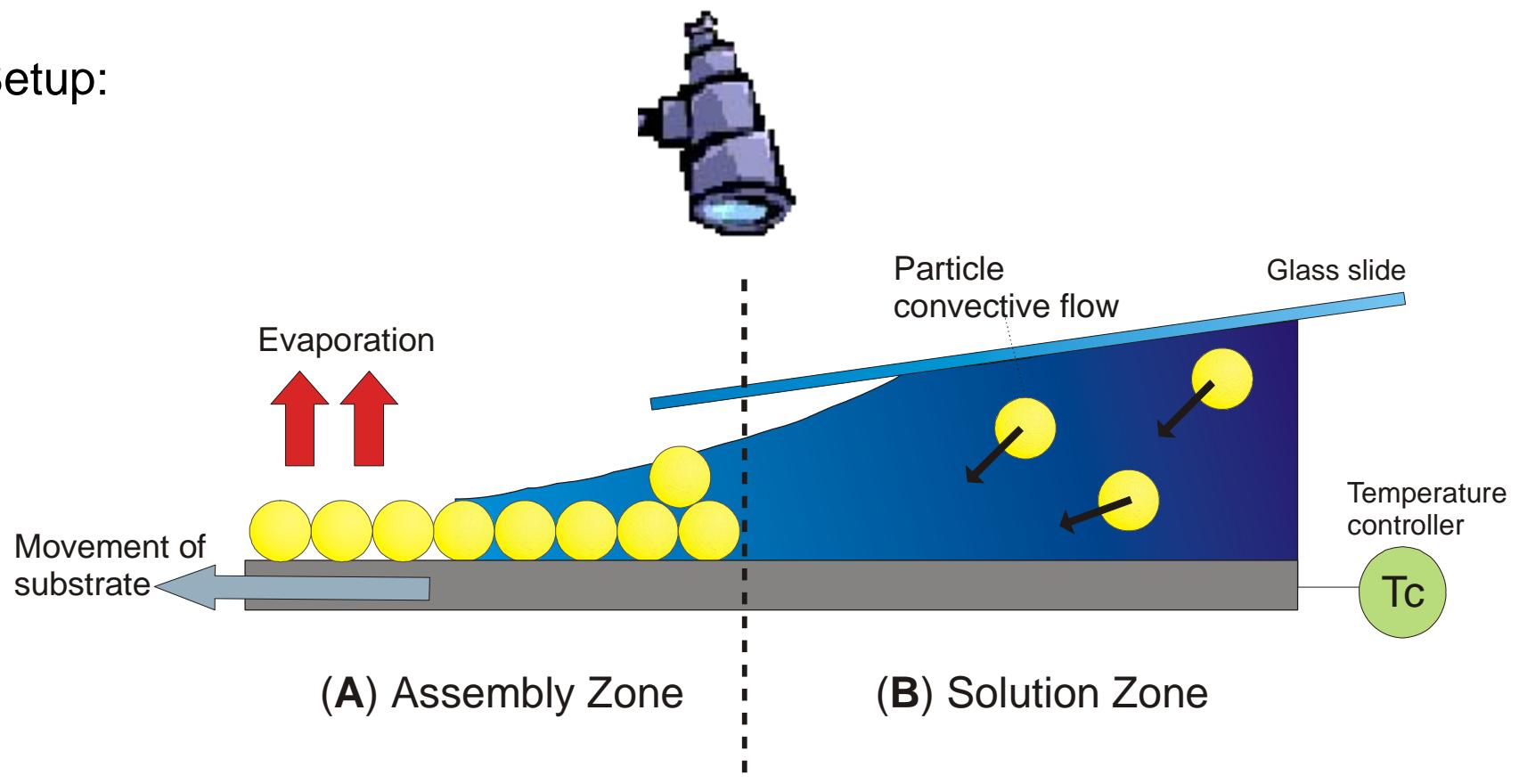


## Nanoparticle-substrate interface chemistry

**NaPa**  
Emerging Nanopatterning Methods

Key question: **What is the role of the interface chemistry** on the assembly (order, reversibility) of large nanoparticles?

Setup:



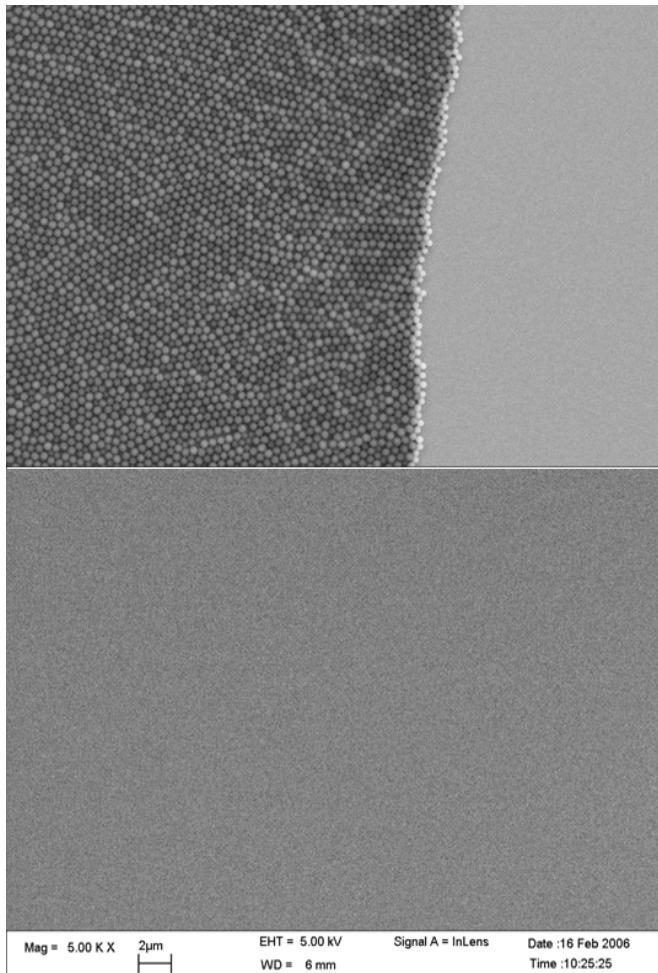
X. Y. Ling, L. Malaquin, D. N. Reinhoudt, H. Wolf, J. Huskens, *Langmuir* **2007**, 23, 9990



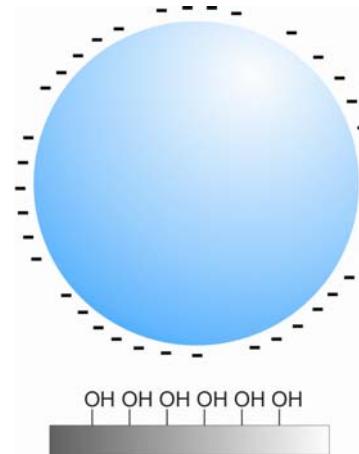
# Nanoparticle-substrate interface chemistry

**NaPa**  
*Emerging Nanopatterning Methods*

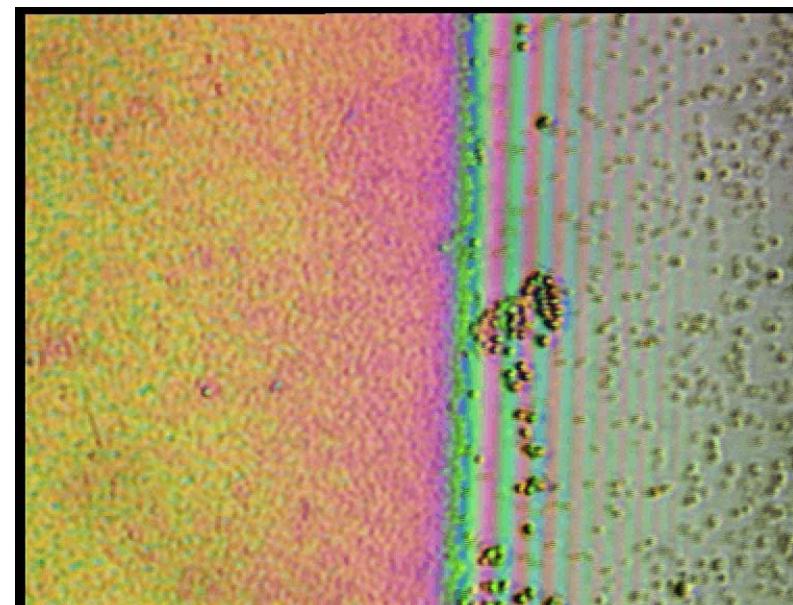
## Physisorption: PS-COOH NPs on clean SiO<sub>2</sub>:



# Assembly zone



## Solution zone

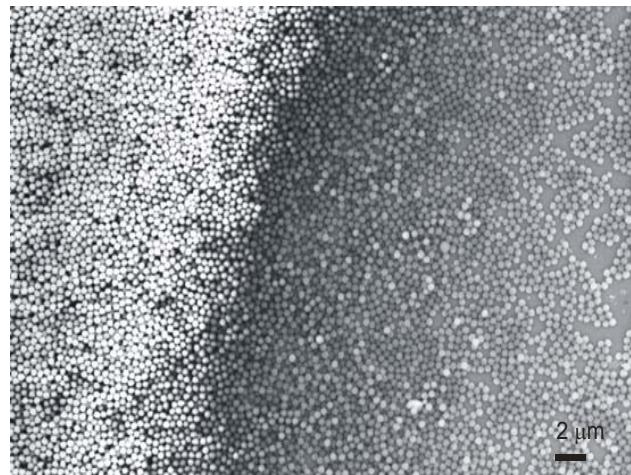




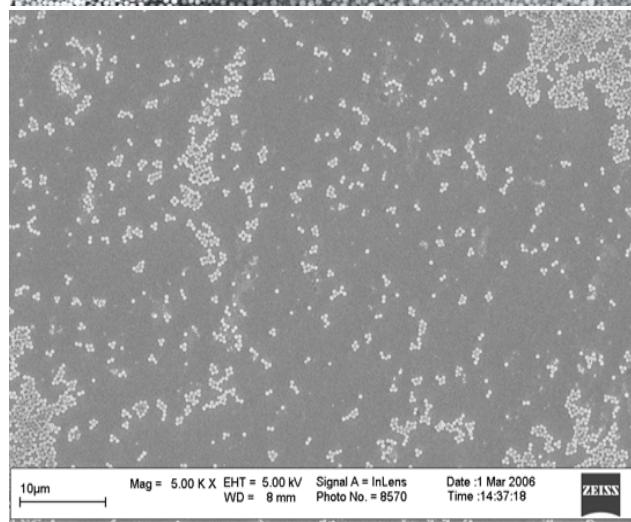
## Nanoparticle-substrate interface chemistry

**NaPa**  
*Emerging Nanopatterning Methods*

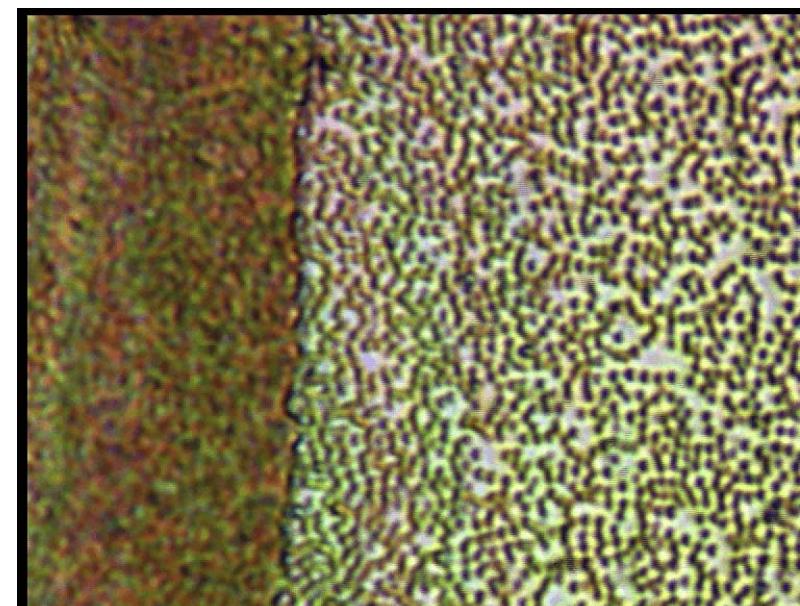
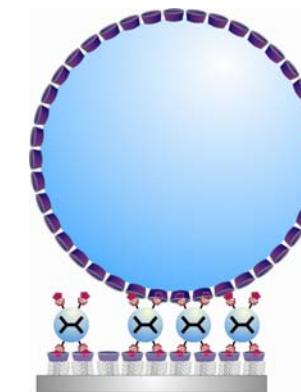
Host-guest interaction: PS-CD NPs on CD SAMs with G1 Fc dendrimers:



Assembly zone



Solution zone



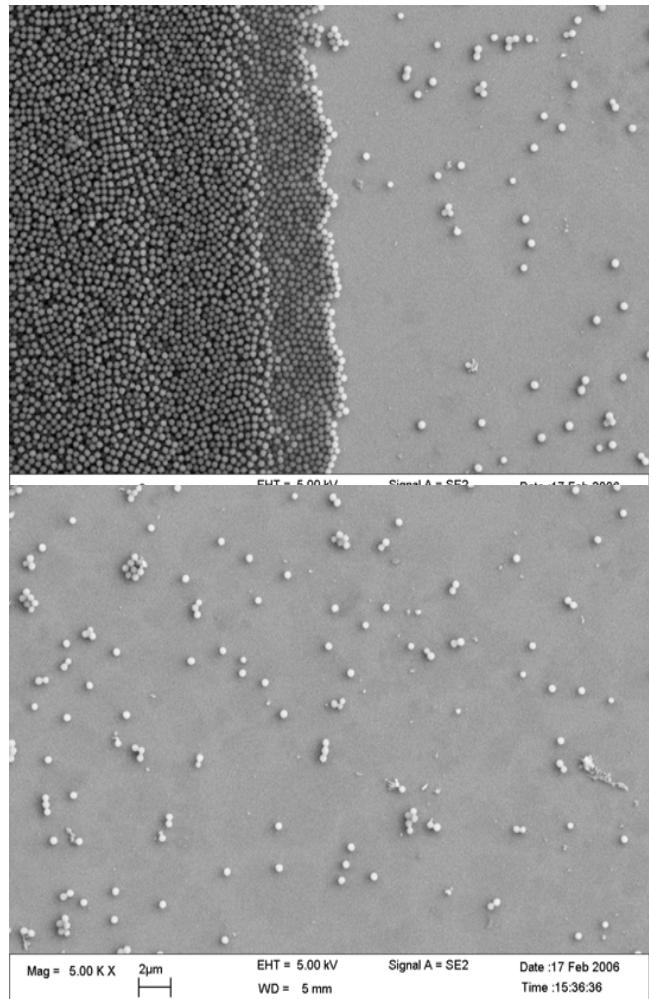


## Nanoparticle-substrate interface chemistry

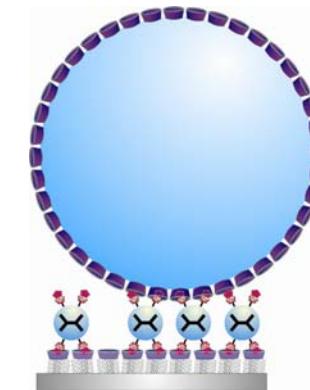
**NaPa**  
*Emerging Nanopatterning Methods*

Host-guest interaction: PS-CD NPs on CD SAMs with G1 Fc dendrimers:

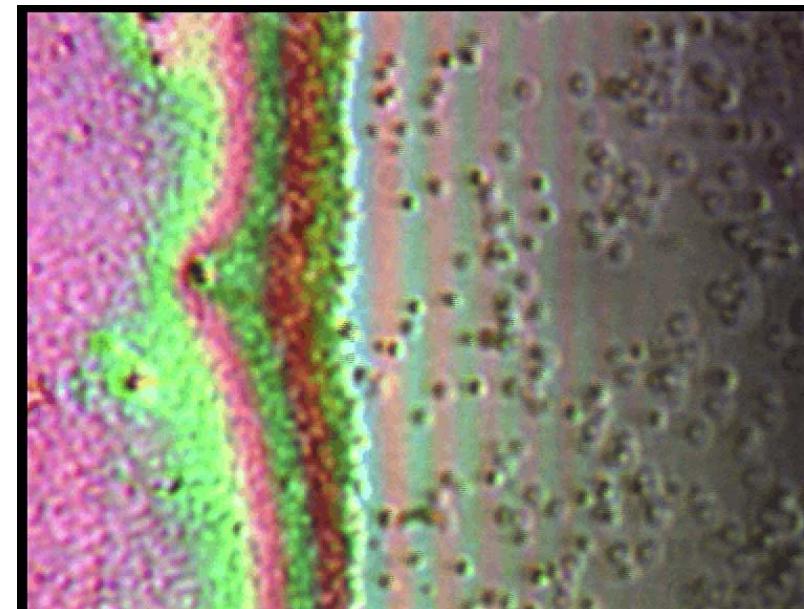
competition by CD in solution



Assembly zone



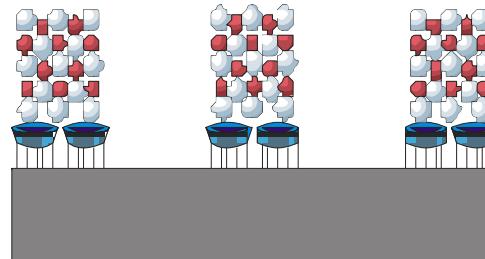
Solution zone



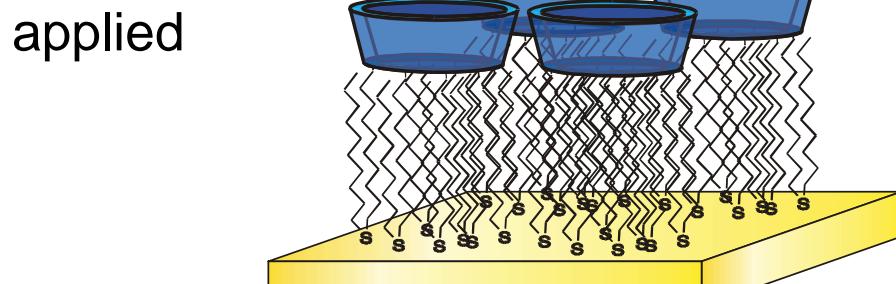


## Summary

Assembly: fundamental  
Patterning:  
fundamental

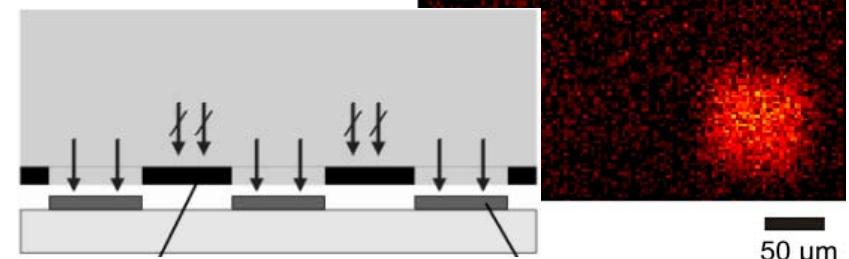


3D nanostructures

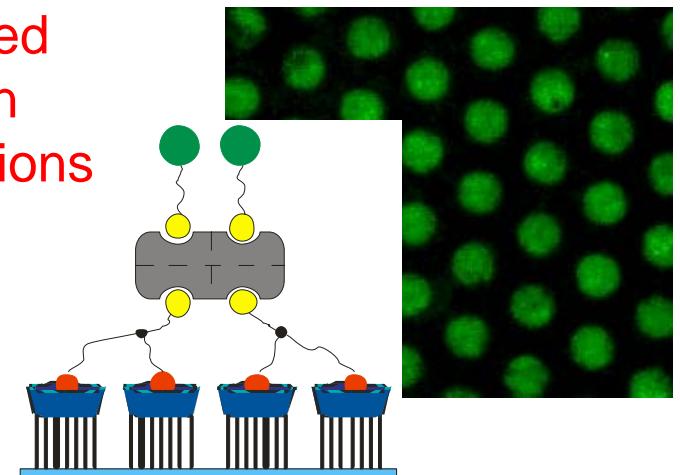


printboards, multivalency,  
supramolecular nanolithography

applied  
flat stamps  
NIL patterning



patterned  
protein  
constructions





## Acknowledgements



### Molecular Nanofabrication group:

Xing Yi Ling  
Manon Ludden  
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Dr. Pascale Maury  
Dr. Maria Peter  
Dr. Venkataramanan Mahalingam  
Prof. Bart Jan Ravoo

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Materials Science and Technology of Polymers, MESA+, University of Twente:

Dr. Mark Hempenius, Prof. G. Julius Vancso

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